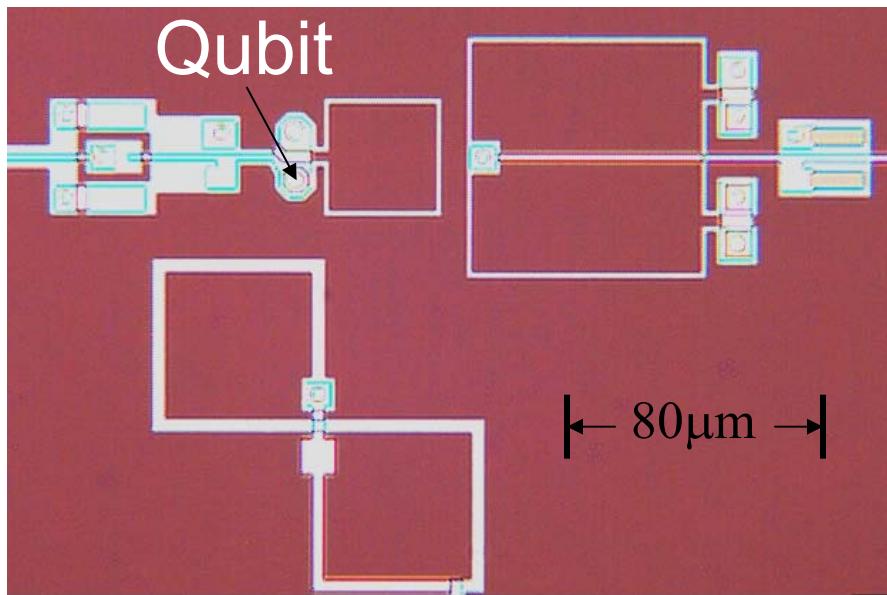


Coherence in Josephson-Junction Qubits

John Martinis – NIST Boulder

Dustin Hite, Ray Simmonds, Robert McDermott, Ken Cooper,
Matthias Steffen, Dave Pappas, Seongshik Oh, Sae Woo Nam



- “Atom” based on nonlinear microwave resonator
- Scalable system using IC fabrication

ARDA



NIST

National Institute of Standards and Technology • Technology Administration • U.S. Department of Commerce



Outline & Key Concepts

Introduction

- Superconductors : Intrinsically low dissipation
- Josephson Junctions : Strong non-linear element

Circuits work

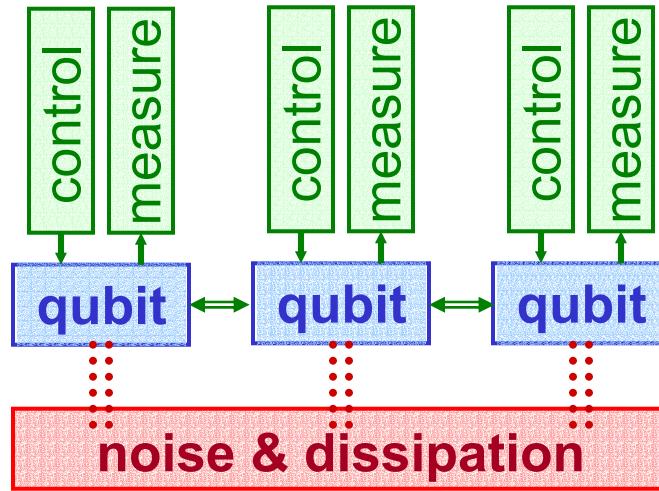
- 1-qubit logic : controlled with bias current
- 2-qubit gates : use linear coupling
- Impedance transformers : decouple qubit from leads
- Low dissipation qubit circuit, Rabi oscillations

Coherence

- New mechanism for decoherence – junction resonances
- Microscopic model (connects: I-V, 1/f noise, decoherence)
- Improve junction fabrication for better coherence
- *Preliminary* tests of coupled-qubits, time-domain

Circuits work well enough that we can study & improve coherence!

Challenge: Coupling vs. Decoherence



Experimental challenge:
Couple qubits to each other,
control, & measure,
not noise and dissipation

Experimental Systems

Atoms

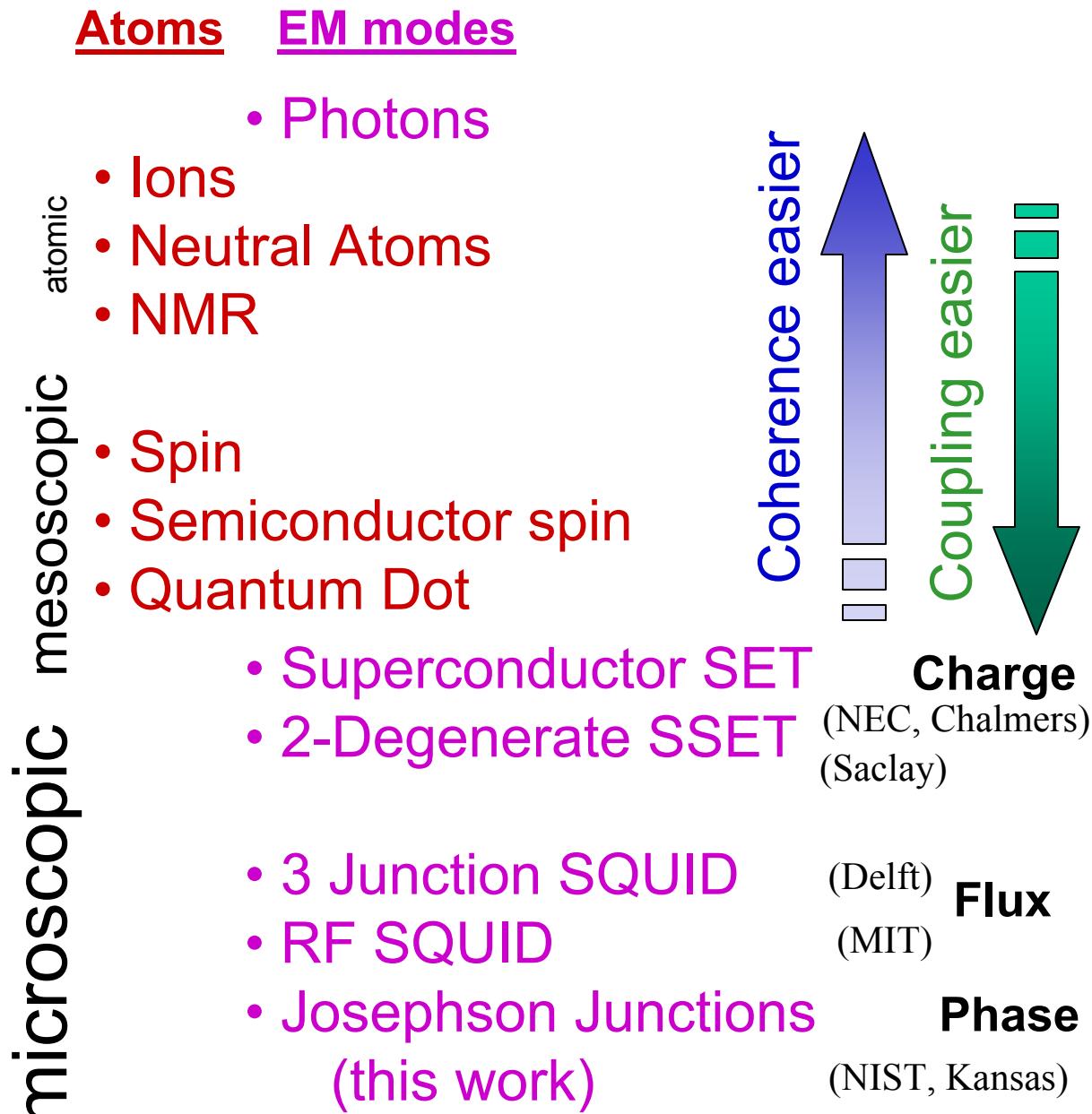
Feynmann (1985):
“it seems that the laws of physics present no barrier to reducing the size of computers until bits are the size of atoms, and quantum behavior holds sway.”

- atomic
 - Ions
 - Neutral Atoms
 - NMR

- mesoscopic
 - Spin
 - Semiconductor spin
 - Quantum Dot

Experimental Systems

Feynmann (1985):
“it seems that the laws of physics present no barrier to reducing the size of computers until bits are the size of atoms, and quantum behavior holds sway.”



Quantum Integrated Circuits

- No Dissipation: Superconductivity

Phase degree of freedom: ϕ

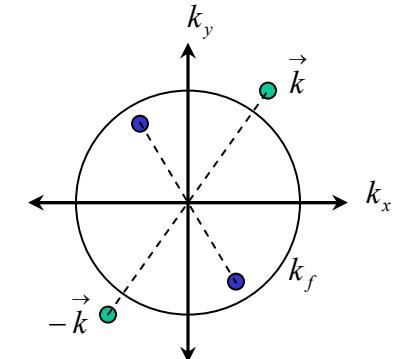
Cooper pairs – states of zero momentum

Only remaining degree of freedom is ϕ

Supercurrent: $j_s \propto \nabla \phi$

Energy gap of excitations: $2\Delta \approx 3.5 kT_c$

No dissipation for $hf < 2\Delta$ (80 GHz for Al)



$$\Psi = \prod_k (u_k + v_k e^{i\phi} c_k^+ c_{-k}^+) |0\rangle$$

- Suppression of Thermal Noise: $kT \ll hf$

Dilution refrigeration: $20 \text{ mK} \ll 0.5 \text{ K}$ (10GHz)

- Non-linearity: Josephson effect

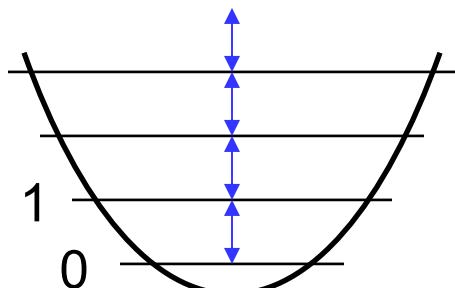
$$I \propto \langle \Psi | T c_{kL} c_{-kL} c_{kR}^+ c_{-kR}^+ | \Psi \rangle - c.c.$$

$$\propto e^{i\phi_L} e^{-i\phi_R} - c.c.$$

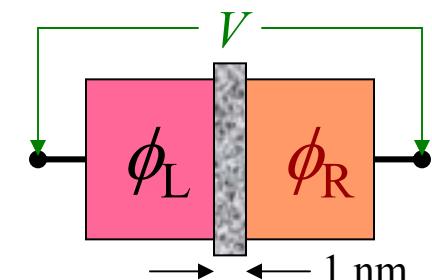
$$= I_0 \sin(\phi_L - \phi_R)$$

$$I = I_0 \sin(\Phi 2\pi/\Phi_0)$$

Non-linear Inductor

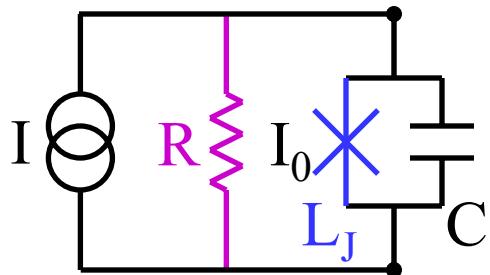


$$\begin{aligned} \phi_L - \phi_R &= (2e/\hbar) \int V dt \\ &= (2\pi/\Phi_0) \Phi \end{aligned}$$



Large Δ gives no dissipation from junction imperfections

Qubit: Nonlinear LC resonator



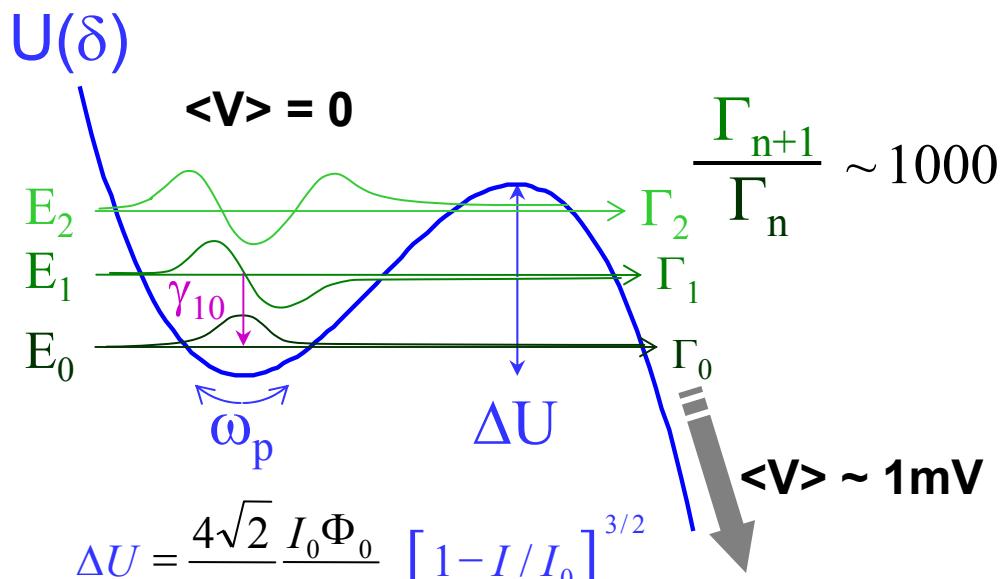
$$I = I_0 \sin \delta$$

$$V = \frac{\Phi_0}{2\pi} \dot{\delta}$$

$$\dot{I}_j = I_0 \cos \delta \quad \dot{\delta} \\ \equiv (1/L_J)V$$

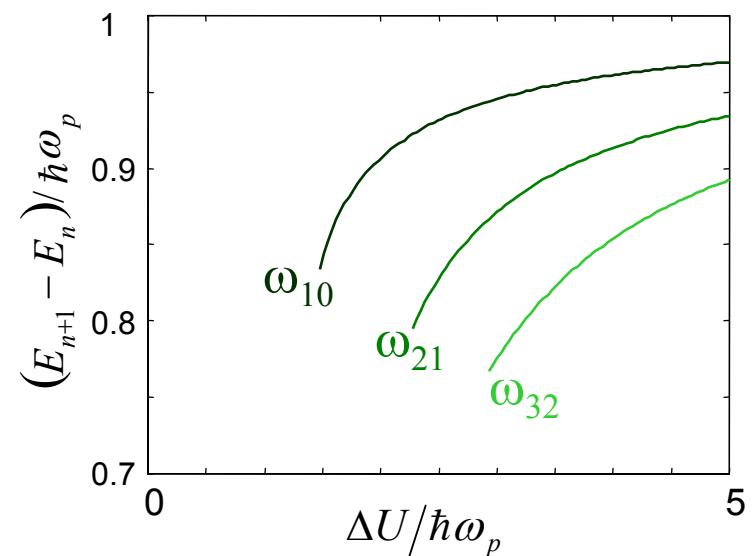
$$L_J = \Phi_0 / 2\pi I_0 \cos \delta$$

nonlinear inductor



$$\omega_p = \left(\frac{2\sqrt{2}\pi}{\Phi_0} \frac{I_0}{C} \right)^{1/2} \left[1 - I/I_0 \right]^{1/4}$$

$\gamma_{10} \approx 1/RC$ Lifetime of state $|1\rangle$



Josephson-Junction Qubit

- State Preparation

Wait $t > 1/\gamma_{10}$ for decay to $|0\rangle$

- Qubit logic with bias control

$$I = I_{dc} + \delta I_{dc}(t) + I_{\mu wc}(t) \cos \omega_{10} t + I_{\mu ws}(t) \sin \omega_{10} t$$

$$\begin{aligned} H_{(2)} = & \sigma_x \bullet I_{\mu wc} \bullet (\hbar / 2\omega_{10} C)^{1/2} / 2 \\ & + \sigma_y \bullet I_{\mu ws} \bullet (\hbar / 2\omega_{10} C)^{1/2} / 2 \\ & + \sigma_z \bullet \delta I_{dc}(t) \bullet (\partial E_{10} / \partial I_{dc}) / 2 \end{aligned}$$

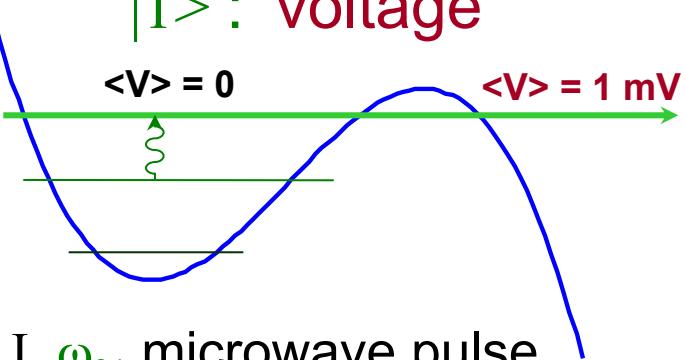
- State Measurement (Junction acts as “photomultiplier”)

$|0\rangle$: zero voltage

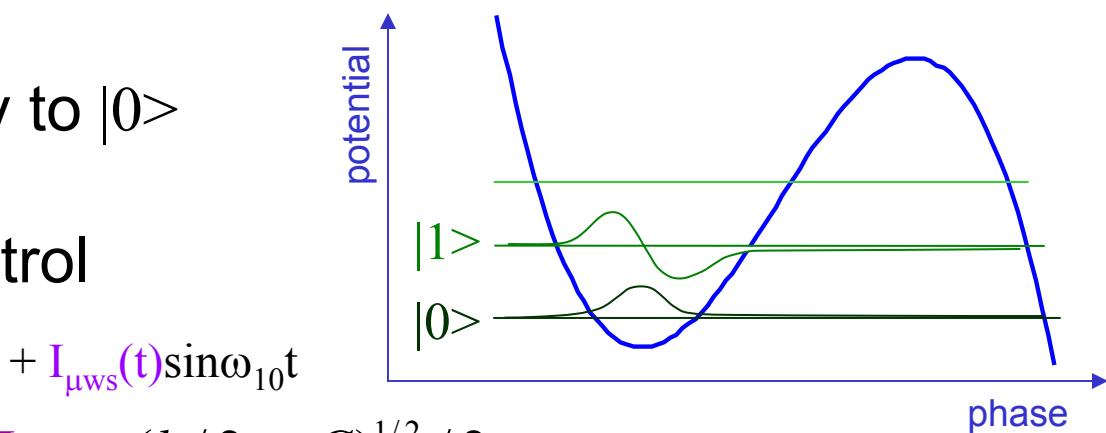
$|1\rangle$: voltage

$$\langle V \rangle = 0$$

$$\langle V \rangle = 1 \text{ mV}$$



I. ω_{21} microwave pulse
 $\tau_{\text{meas}} \sim 100 \text{ ns}$, Fidelity $\sim 90\%$



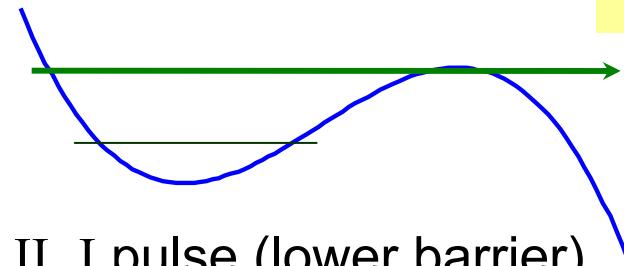
$$H_{(2)} = \sigma_x \bullet I_{\mu wc} \bullet (\hbar / 2\omega_{10} C)^{1/2} / 2$$

$$+ \sigma_y \bullet I_{\mu ws} \bullet (\hbar / 2\omega_{10} C)^{1/2} / 2$$

$$+ \sigma_z \bullet \delta I_{dc}(t) \bullet (\partial E_{10} / \partial I_{dc}) / 2$$

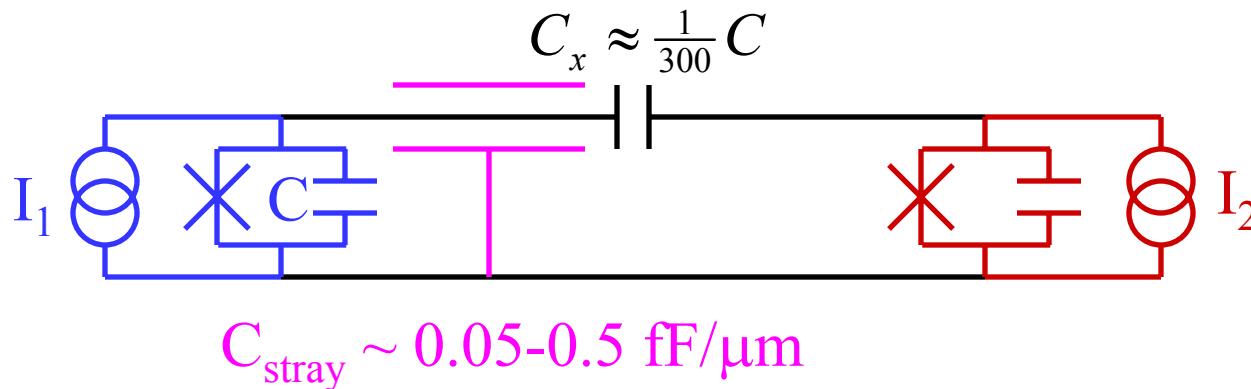
With $\Gamma_i / \Gamma_{i-1} \sim 500$

Expect fidelity
 $> 95\%-99\% !!$



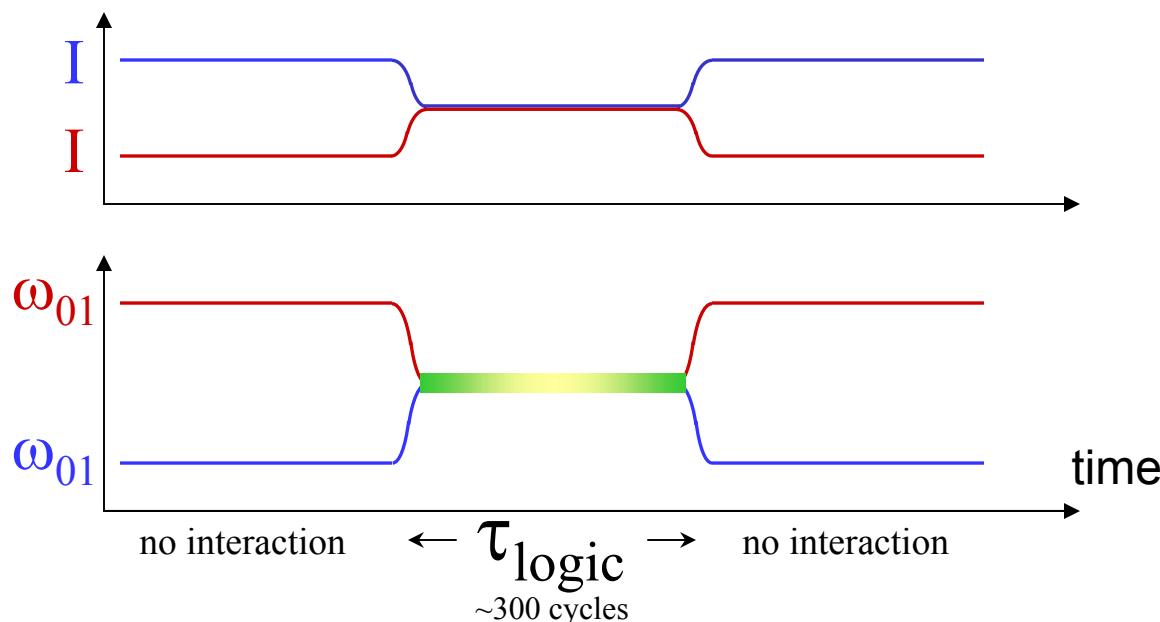
II. I pulse (lower barrier)
 $\tau_{\text{meas}} \sim 5 \text{ ns}$, Fidelity $\sim 70\%$

Qubit Logic with Capacitive Coupling



$$H_{\text{int}} \propto C_x q_1 q_2$$
$$\propto \sigma_{y1} \sigma_{y2}$$

Turn-off interaction
with single qubit
operations (eg. NMR)



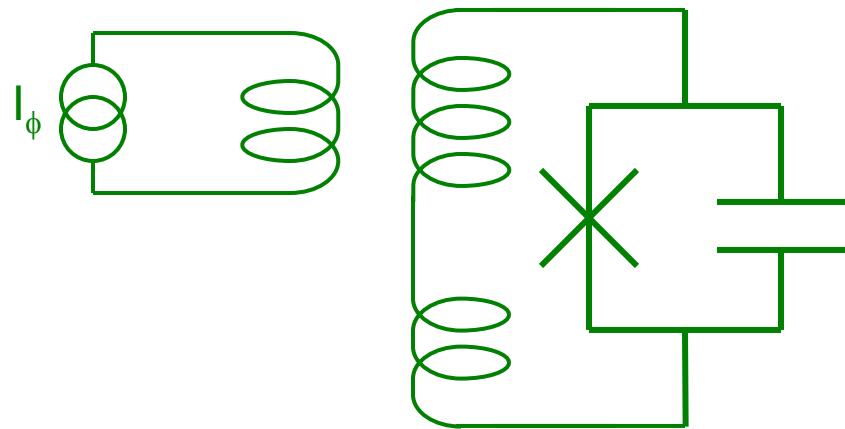
Modulate interaction by
de-tuning resonance
frequencies

Theory (Maryland):
CNOT & Phase gates

Experiment (Maryland)
Level splittings

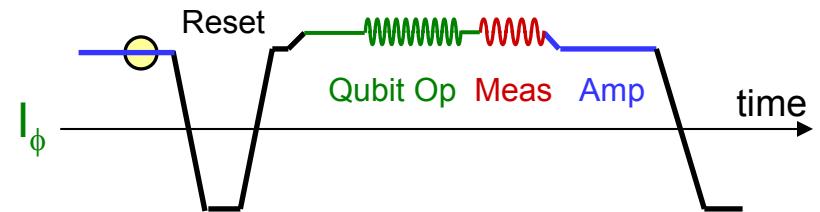
Large junctions – C_{stray} unimportant
Coupling to more qubits, lower crosstalk

Qubit operation → Measurement → Readout

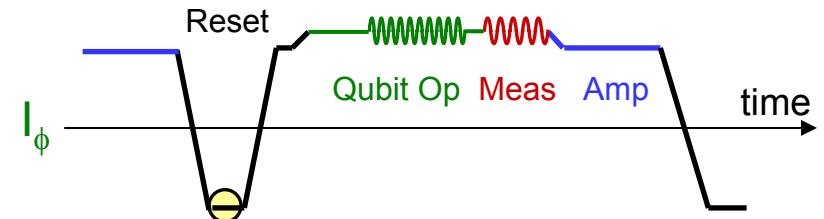
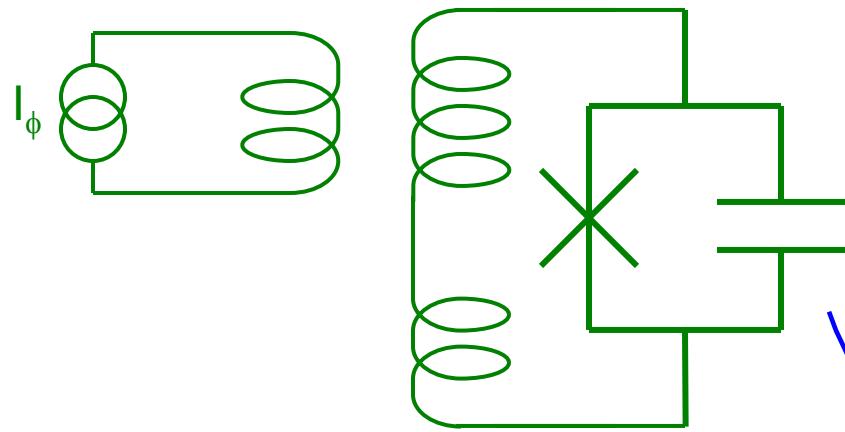


Qubit
Cycle

$U(\delta)$



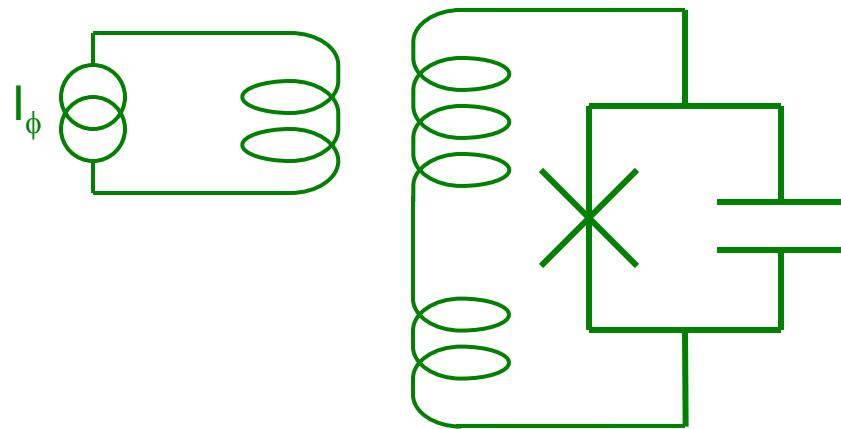
Qubit operation → Measurement → Readout



Qubit
Cycle

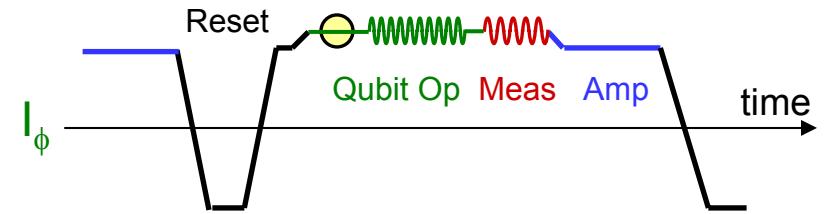
$U(\delta)$

Qubit operation → Measurement → Readout



Qubit
Cycle

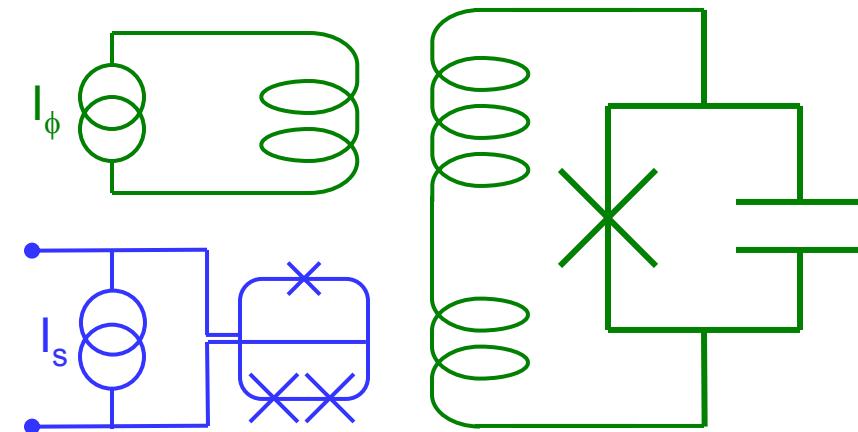
$U(\delta)$



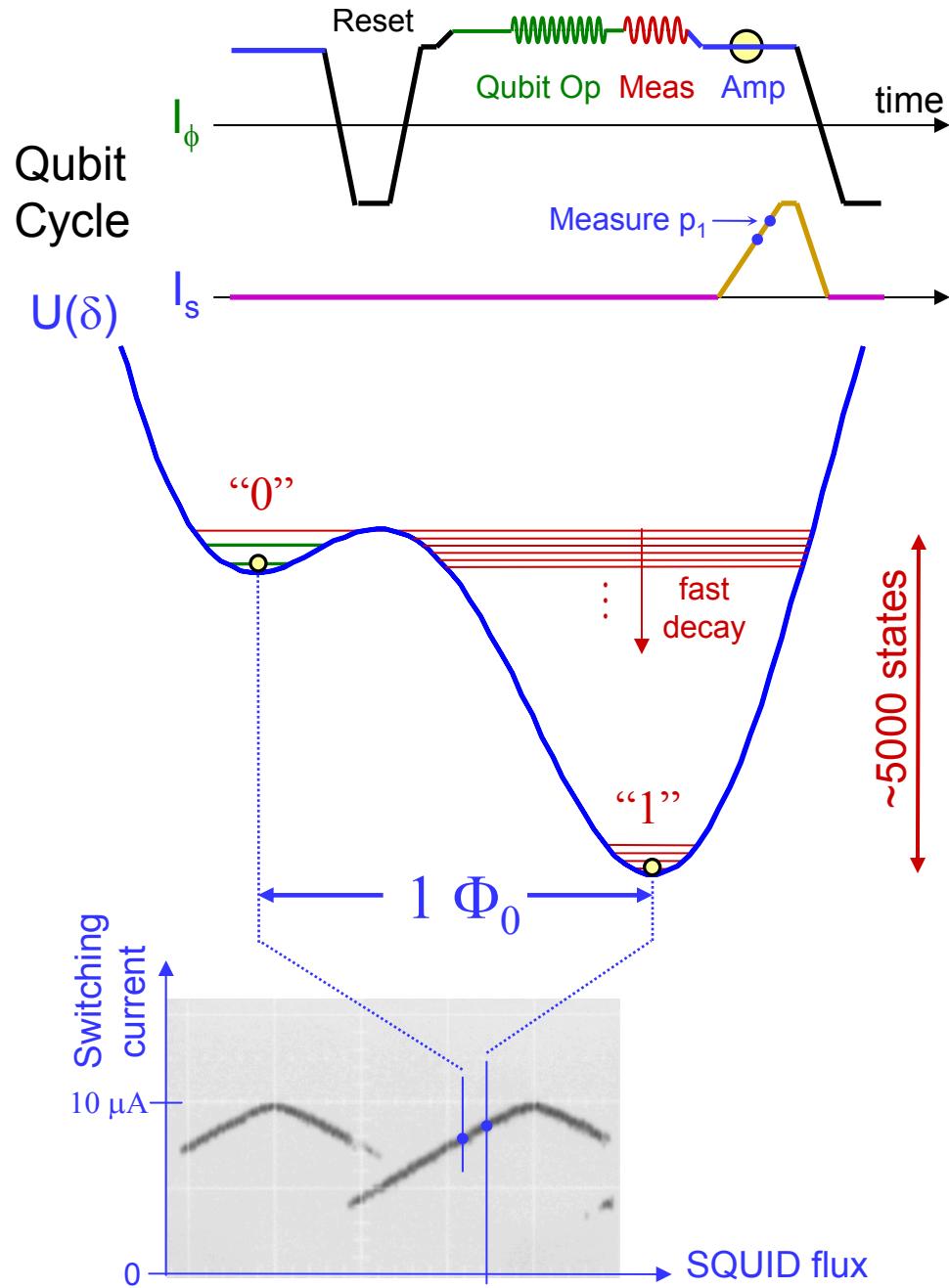
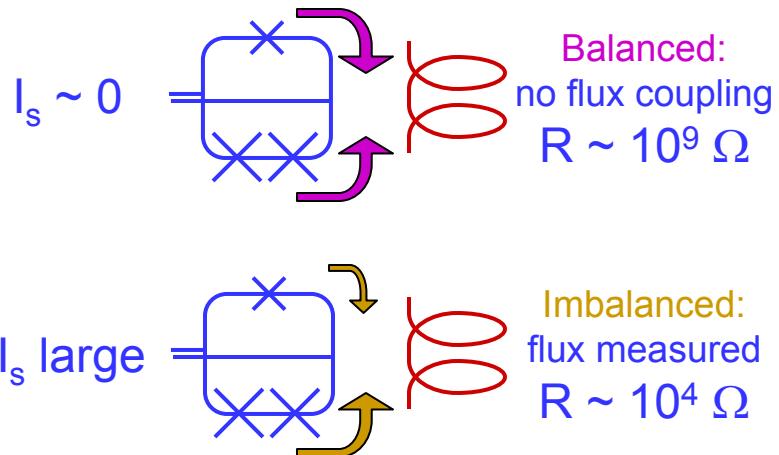
↓
 ~ 5000 states

⋮
fast
decay

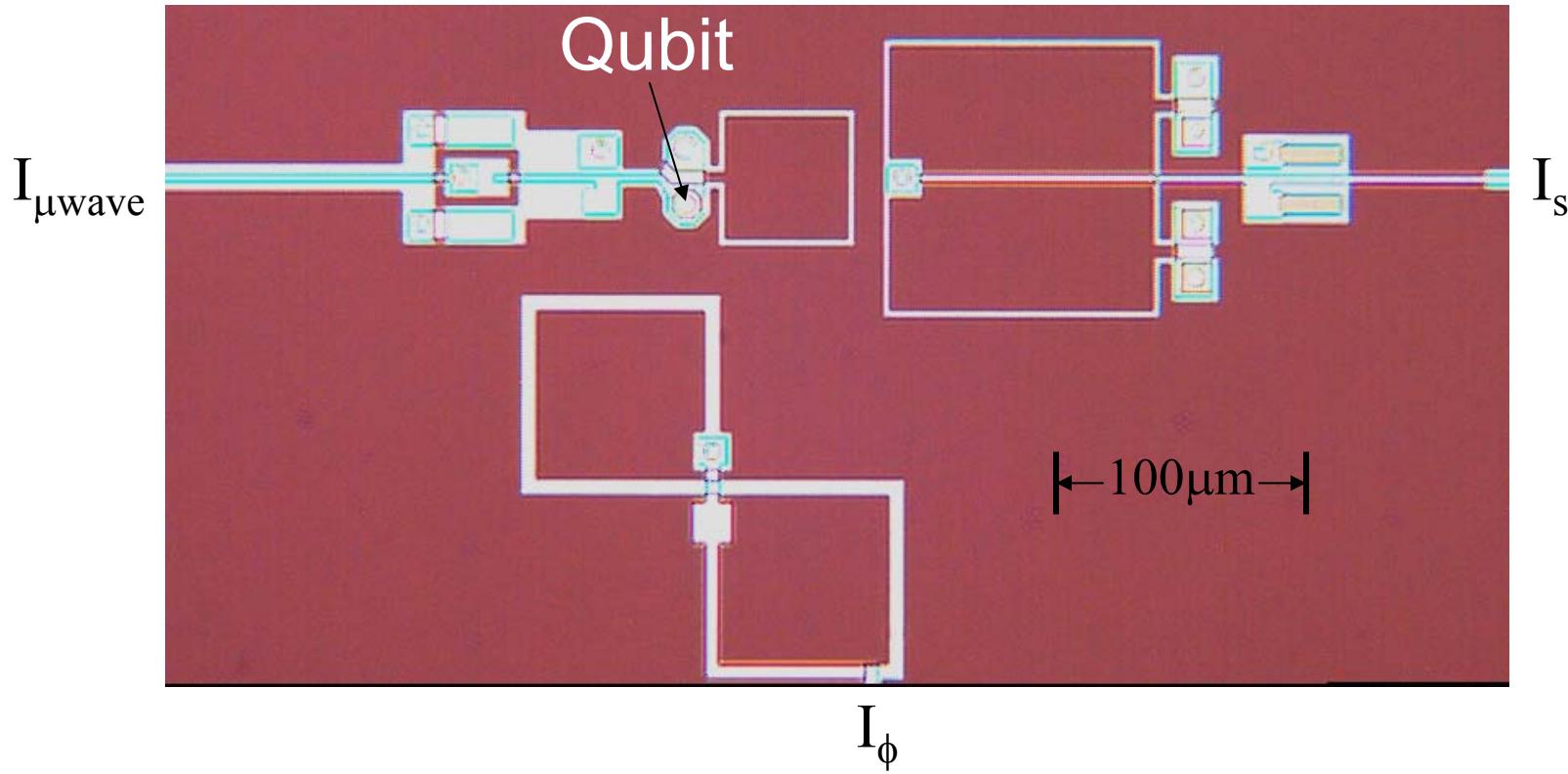
Qubit operation → Measurement → Readout



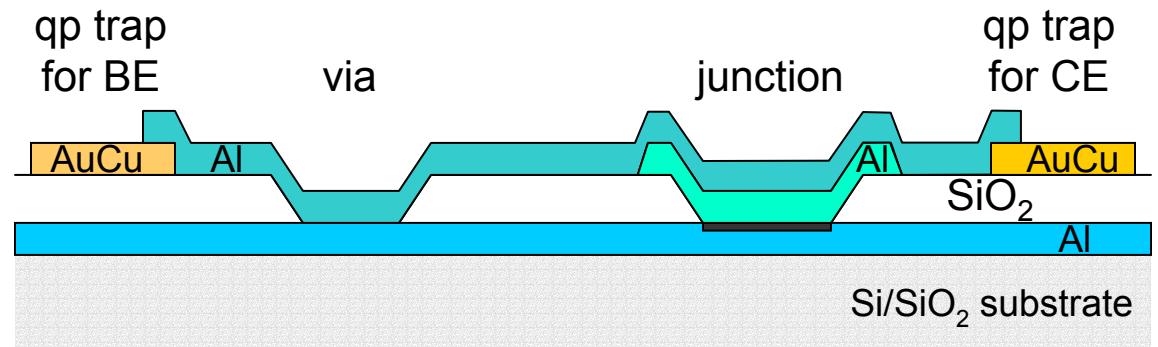
Amplifier (and its dissipation!) turned on & off with I_s
- Adjustable T_1 -

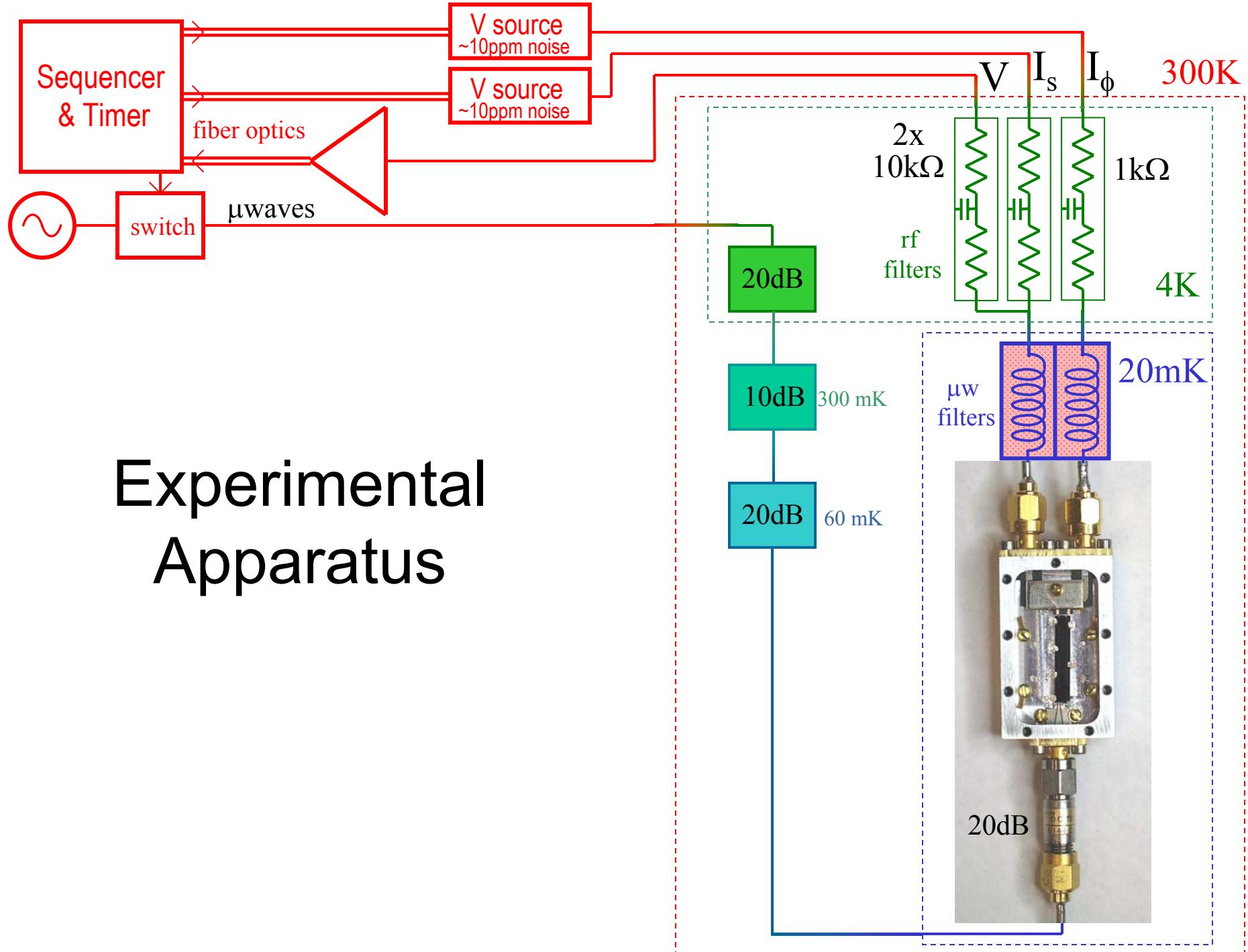


IC Fabrication

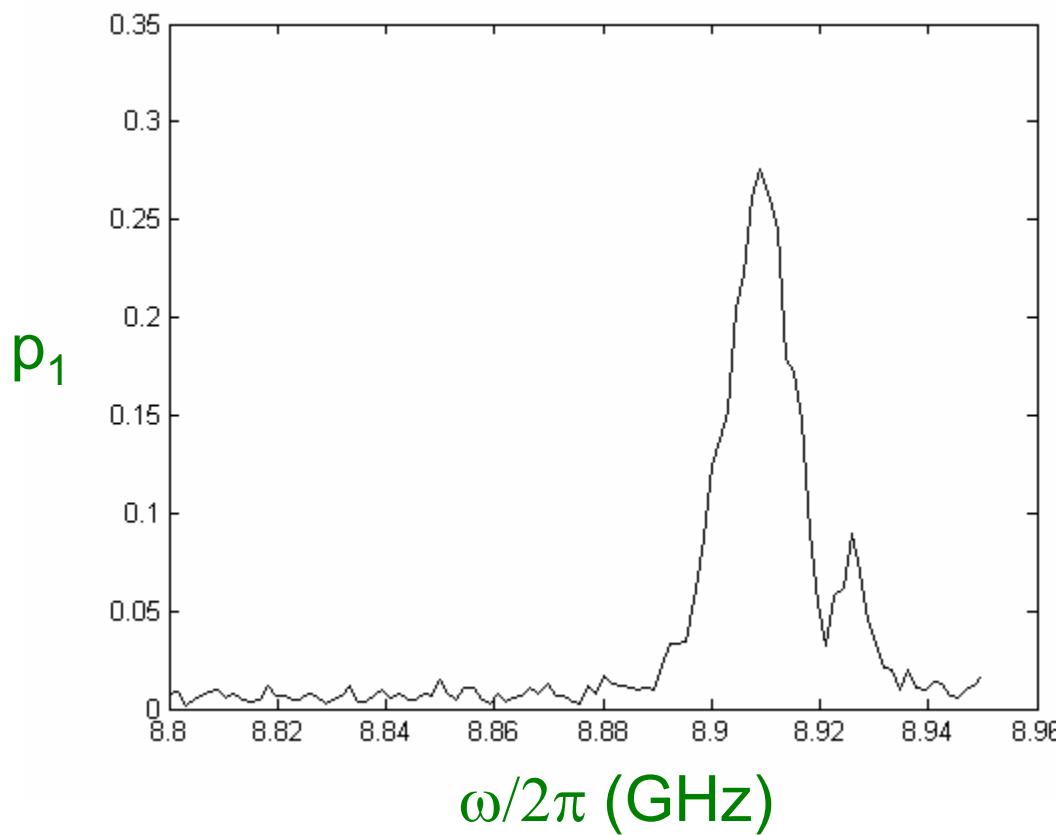
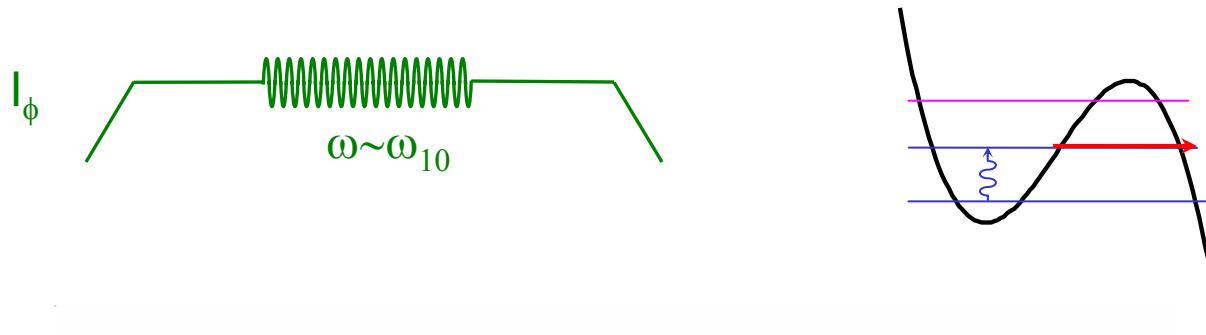


Al junction process
& optical lithography

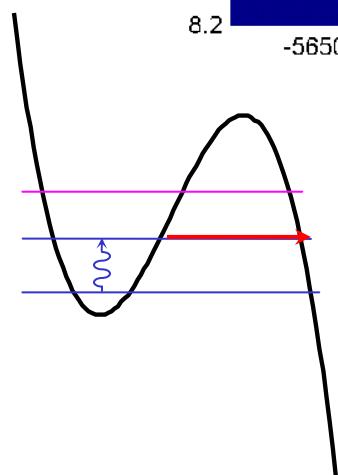
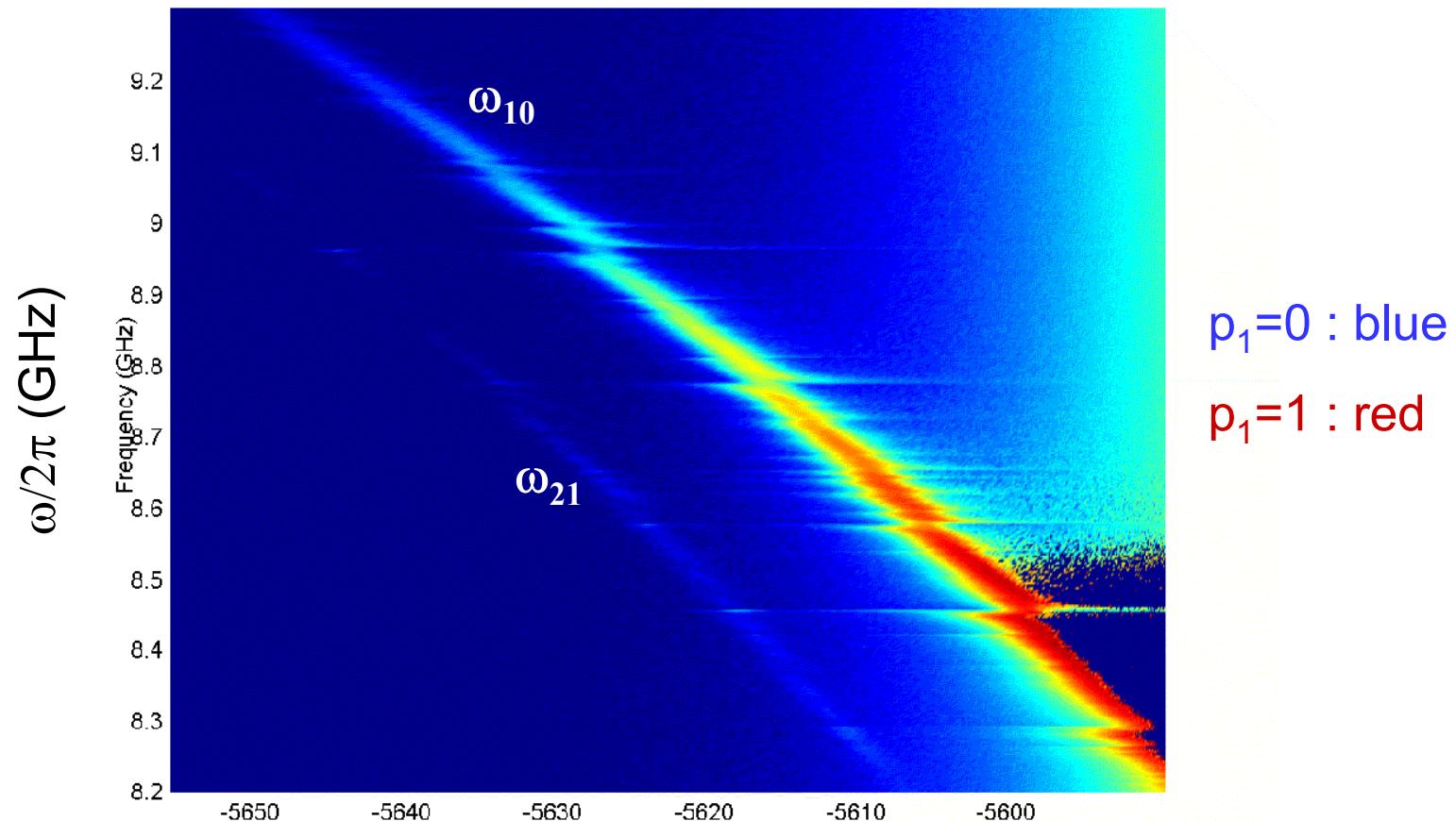




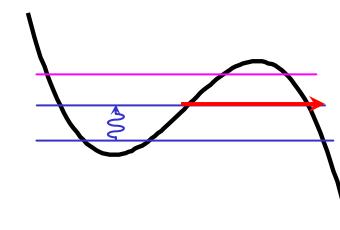
Spectroscopy



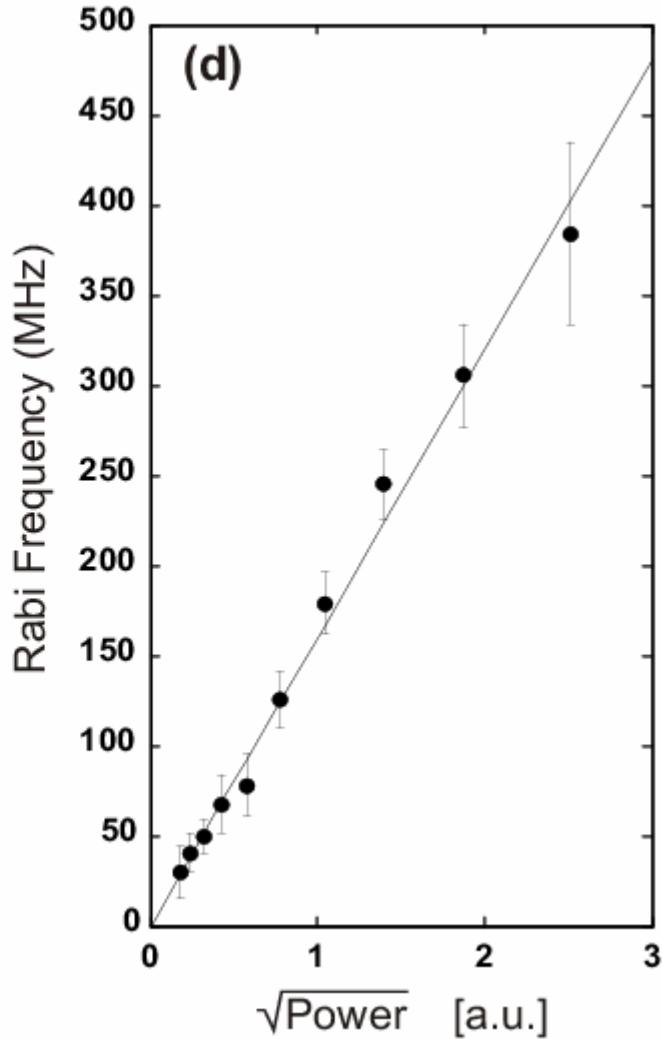
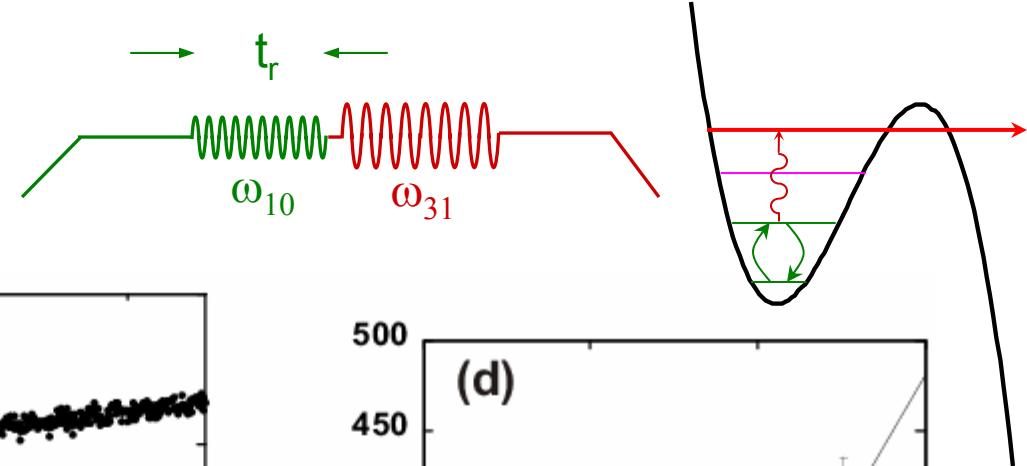
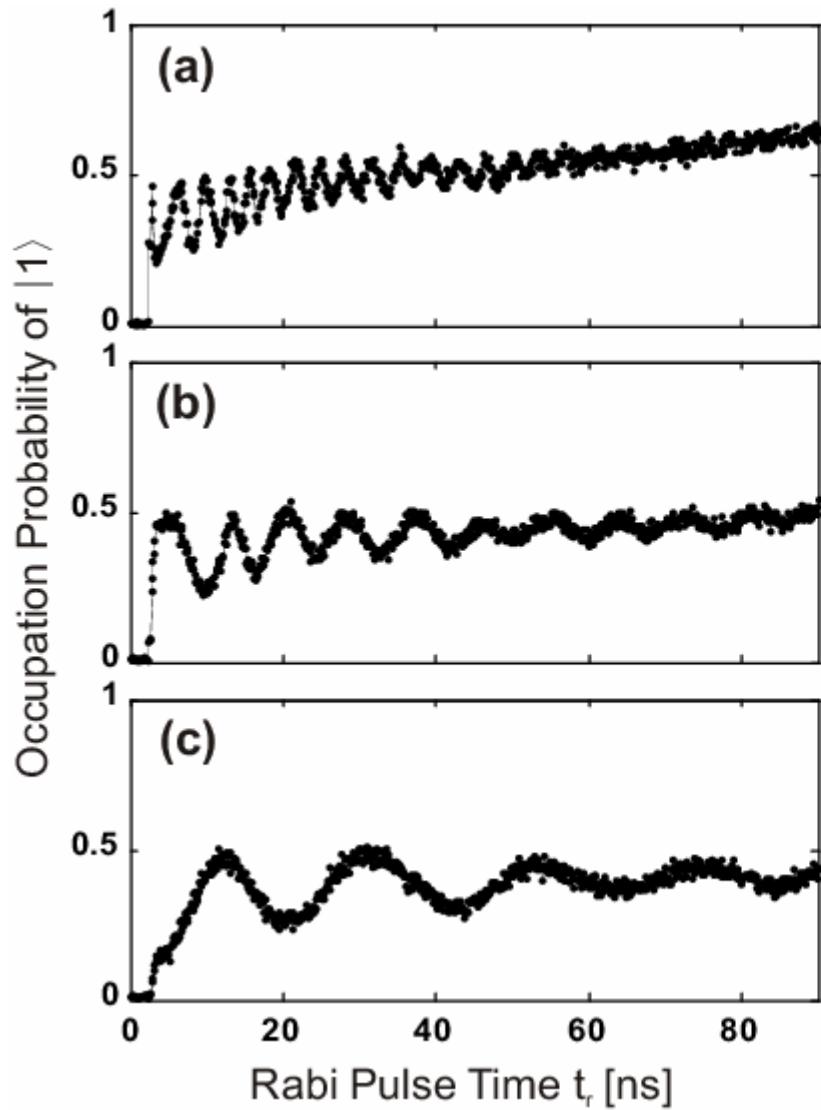
Energy Levels vs. Bias Current

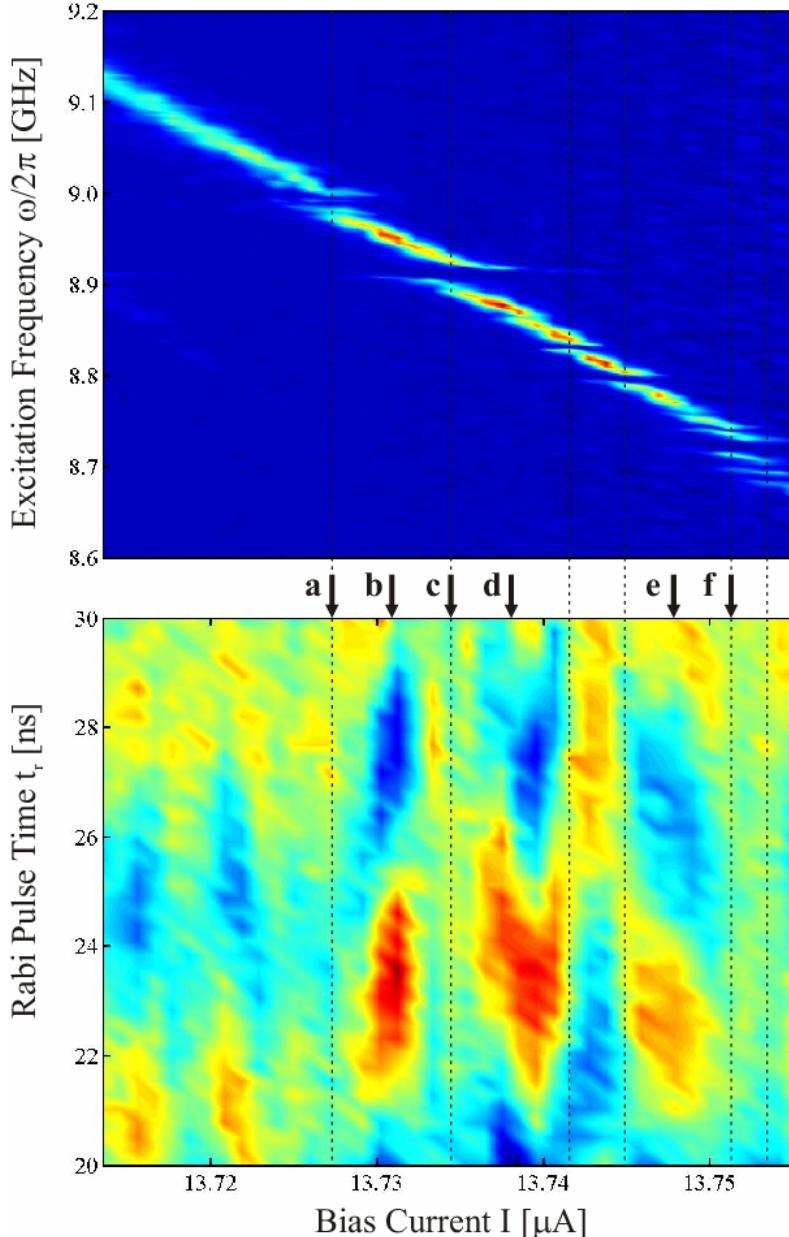


Increasing I (arb. Units)



Rabi Oscillations

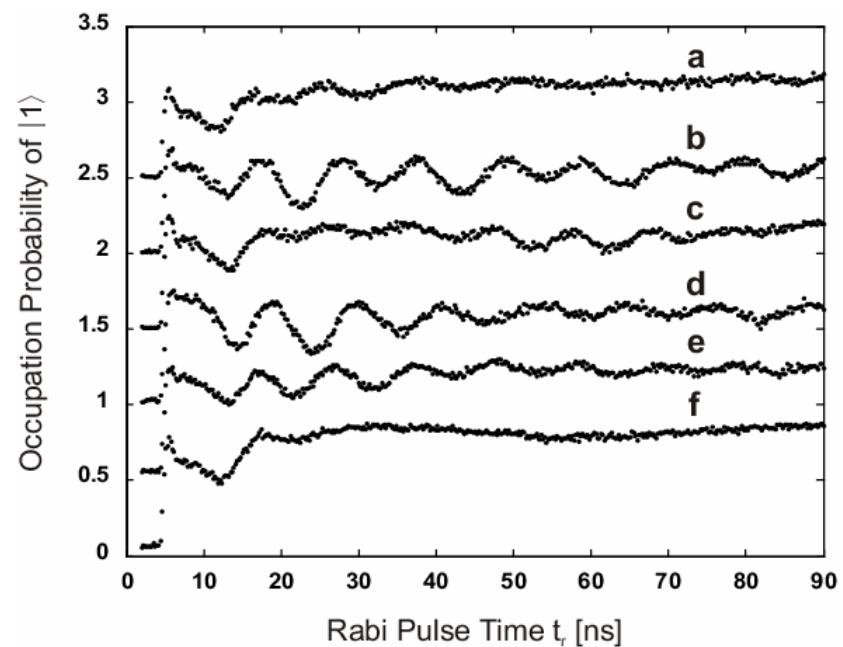




Resonances & Rabi Oscillations

$p_1=0$: blue

$p_1=1$: red

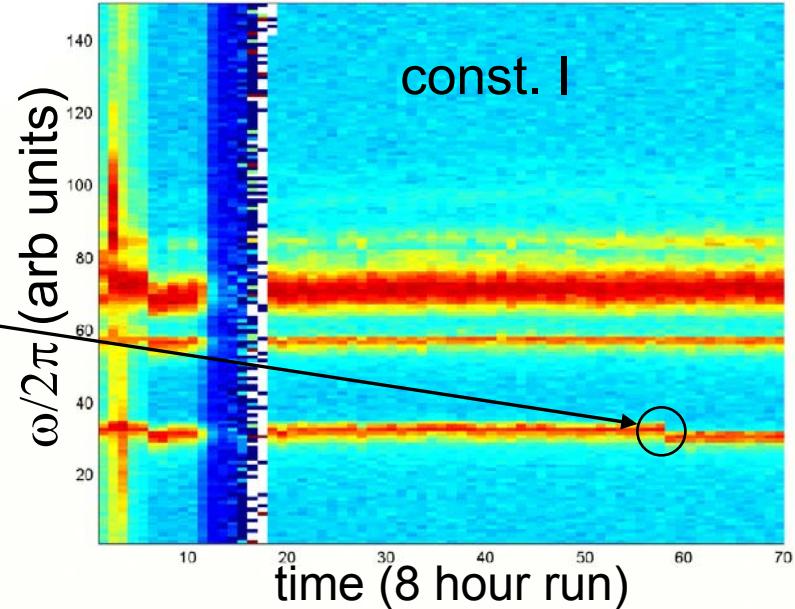


Rabi oscillations disappear
at spurious resonances

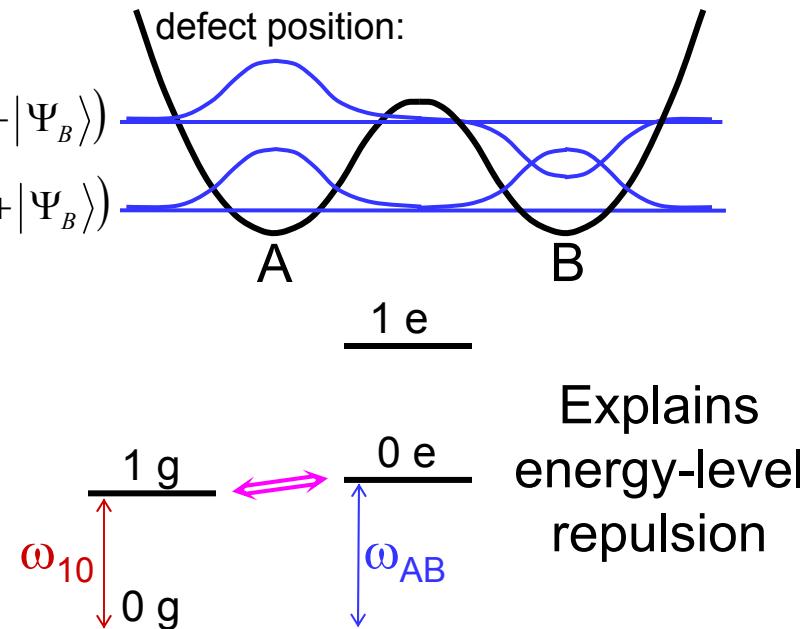
Reduced coherence
amplitude

What causes extra resonances?

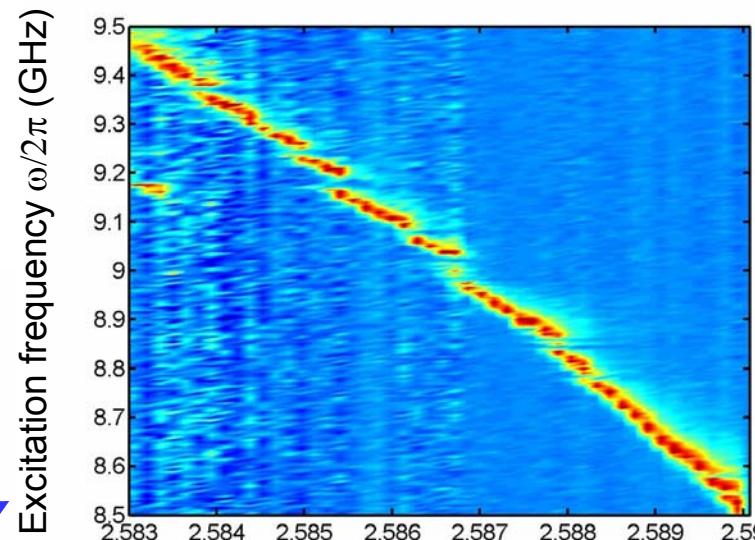
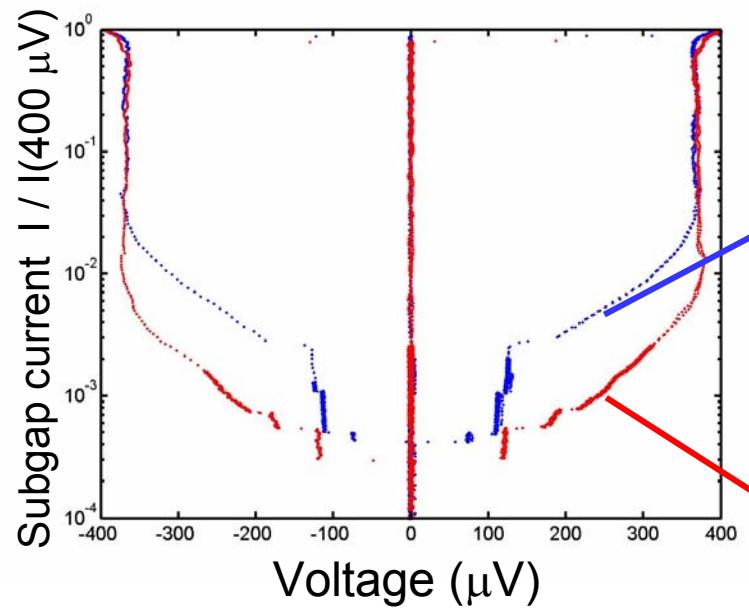
- Resonance ‘fingerprint’ changes at 300K (not 4K)
- Frequency shifts rule-out macroscopic EM modes
- Model as modulation of I_0 from resonant defect motion



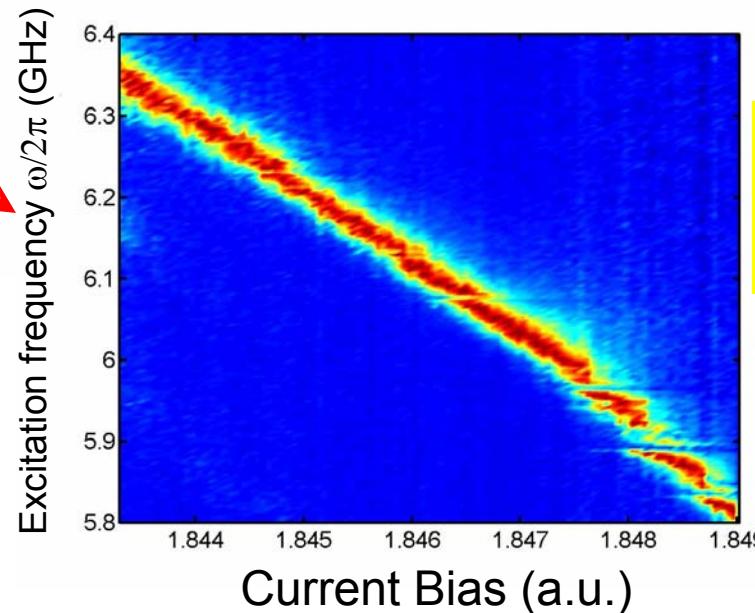
$$\begin{aligned}
 H_{\text{int}} &= \left(-\frac{\Phi_0 I_{0A}}{2\pi} \cos \delta \right) \otimes |\Psi_A\rangle\langle\Psi_A| \\
 &\quad + \left(-\frac{\Phi_0 I_{0B}}{2\pi} \cos \delta \right) \otimes |\Psi_B\rangle\langle\Psi_B| \\
 &= \frac{\Delta I_0}{2} \sqrt{\frac{\hbar}{2\omega_{10}C}} (|0\rangle\langle 1| \otimes |e\rangle\langle g| + |1\rangle\langle 0| \otimes |g\rangle\langle e|)
 \end{aligned}$$



Resonance Size Correlated with Fabrication !



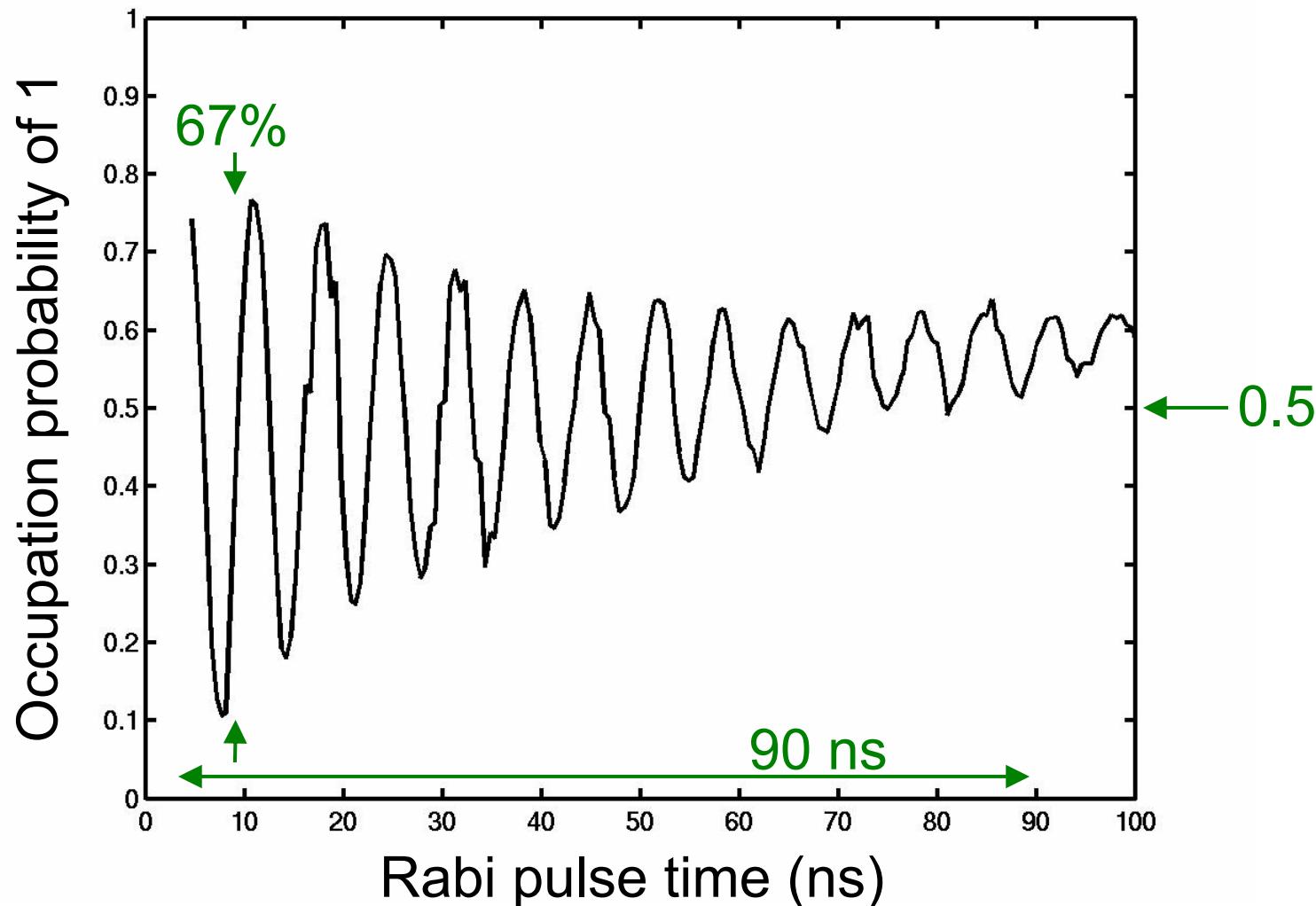
Al
Ion Mill clean
Oxidize
Al



“Clean” Fab. :
Lower subgap I
Smaller Res.

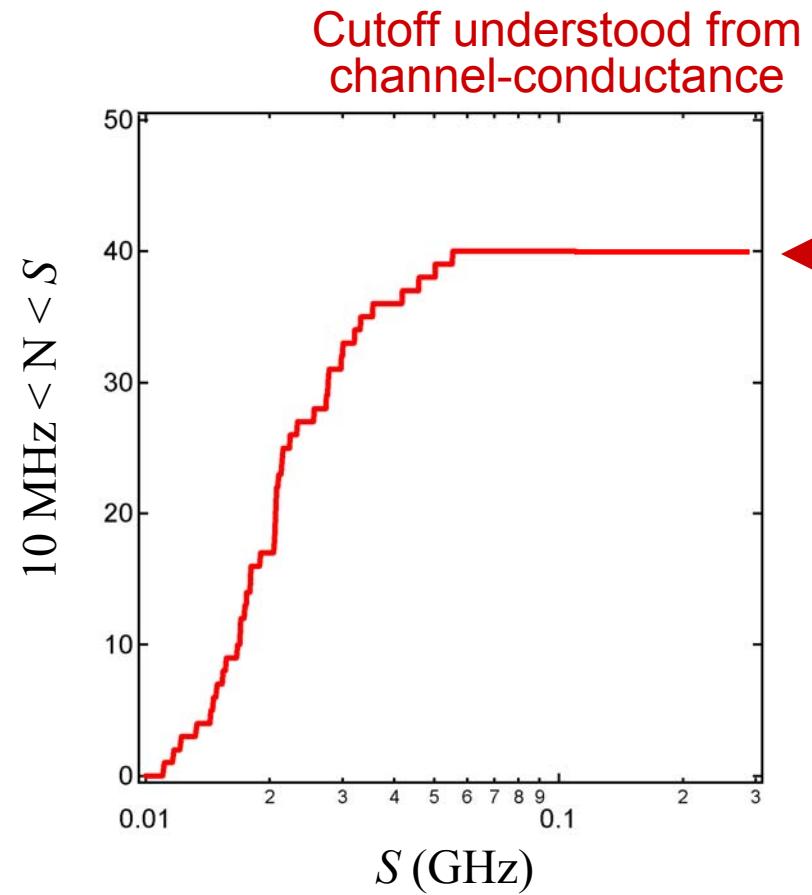
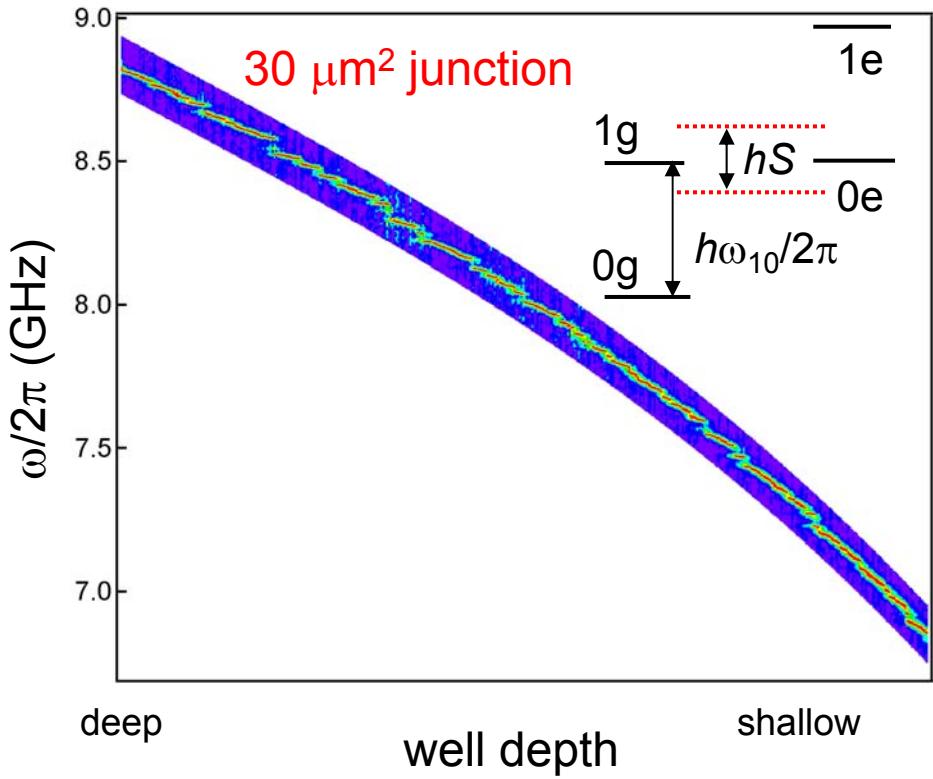
Al
Oxidize
Al

Rabi Oscillations for Trilayer Junction

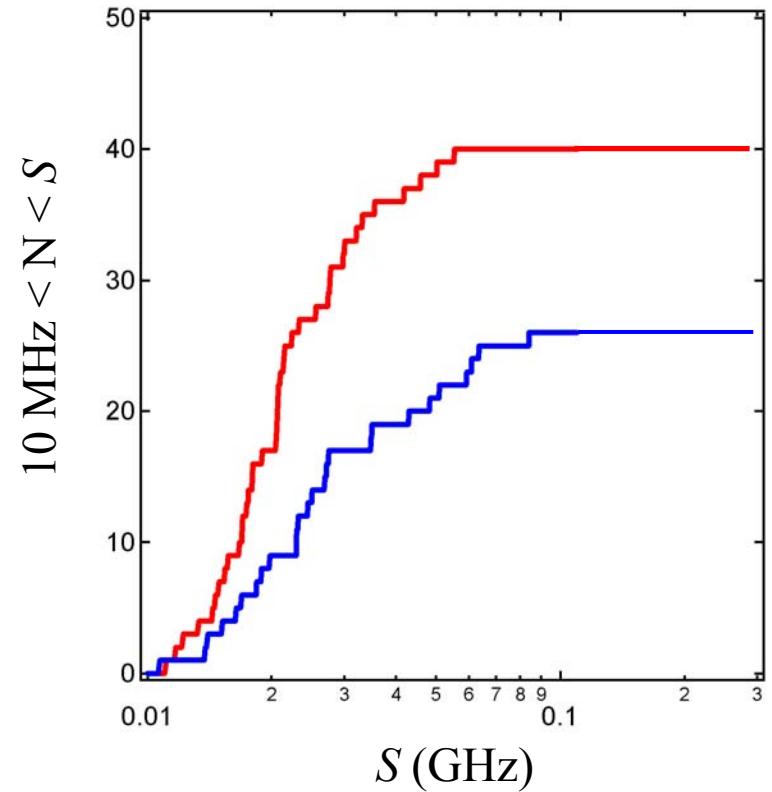
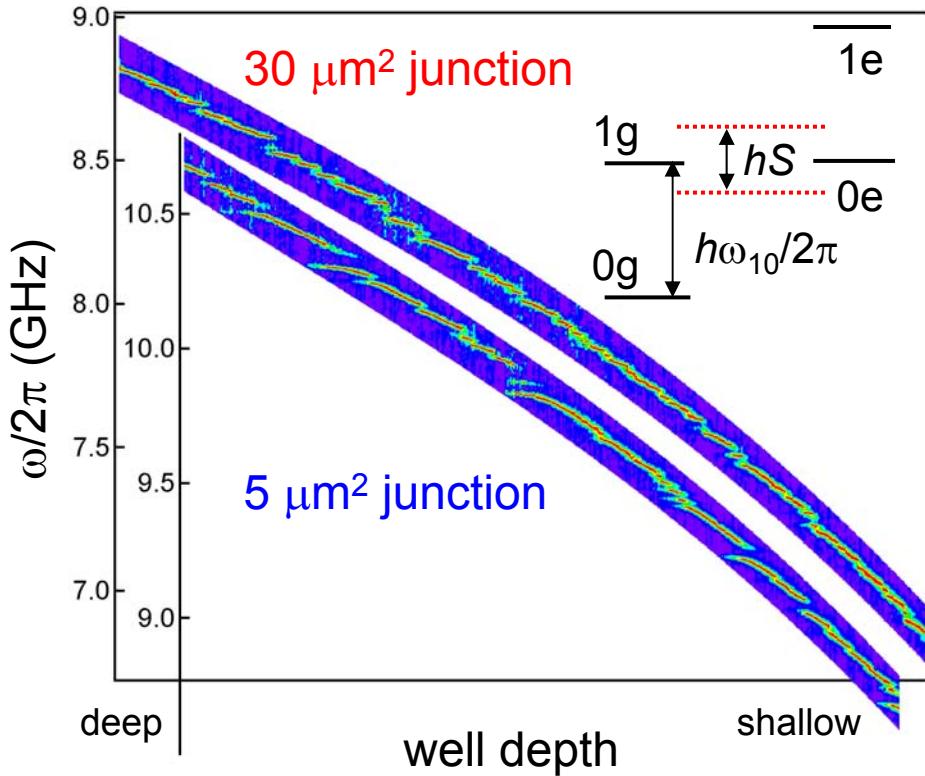


15 qubits: Typically 40-50% amplitude

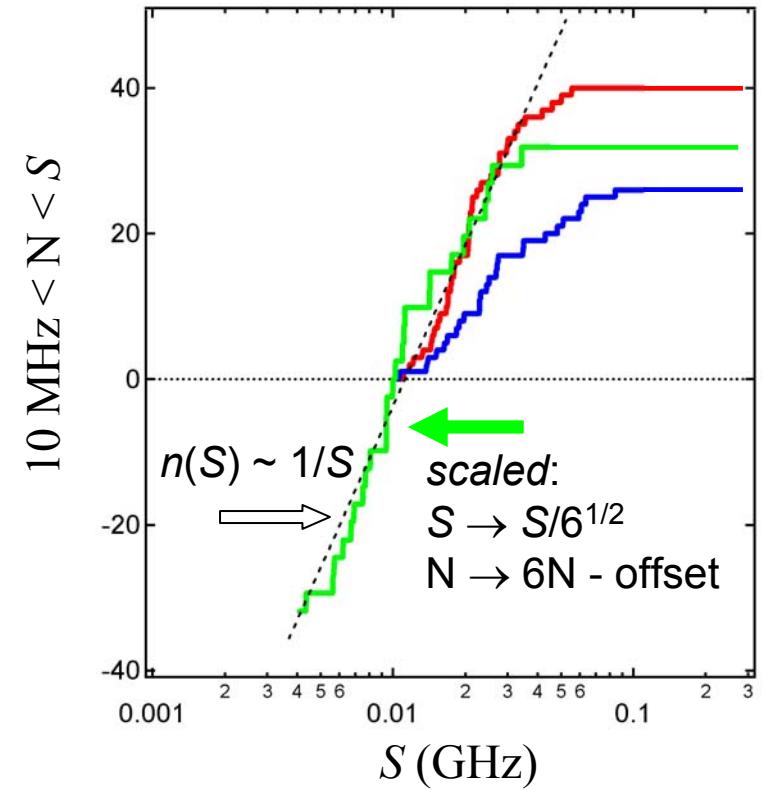
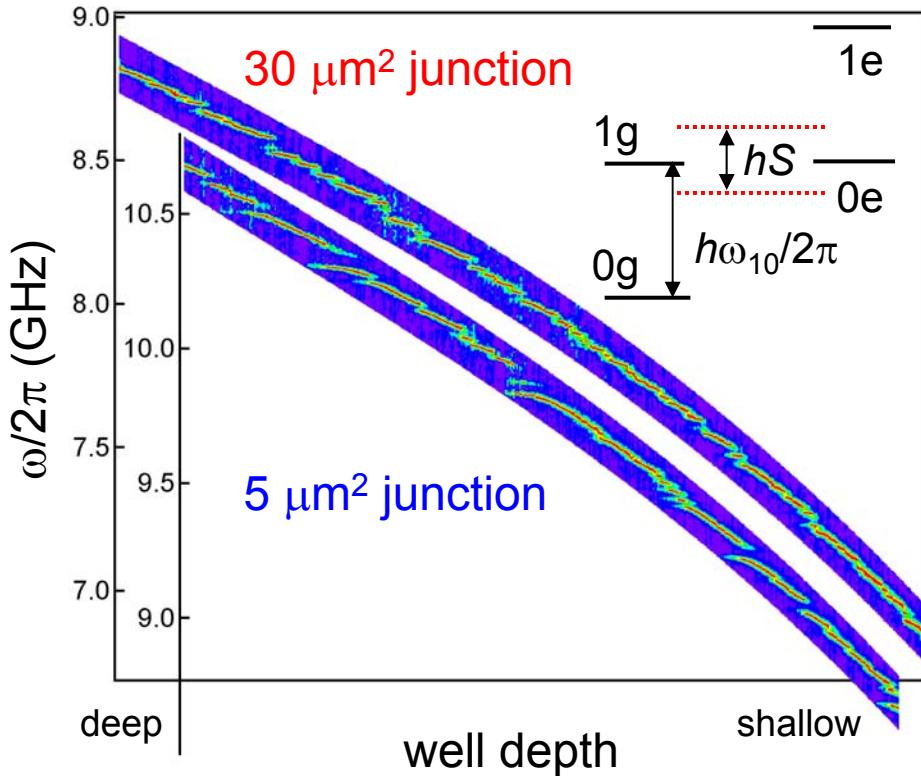
Resonator Magnitudes



Resonator Magnitudes

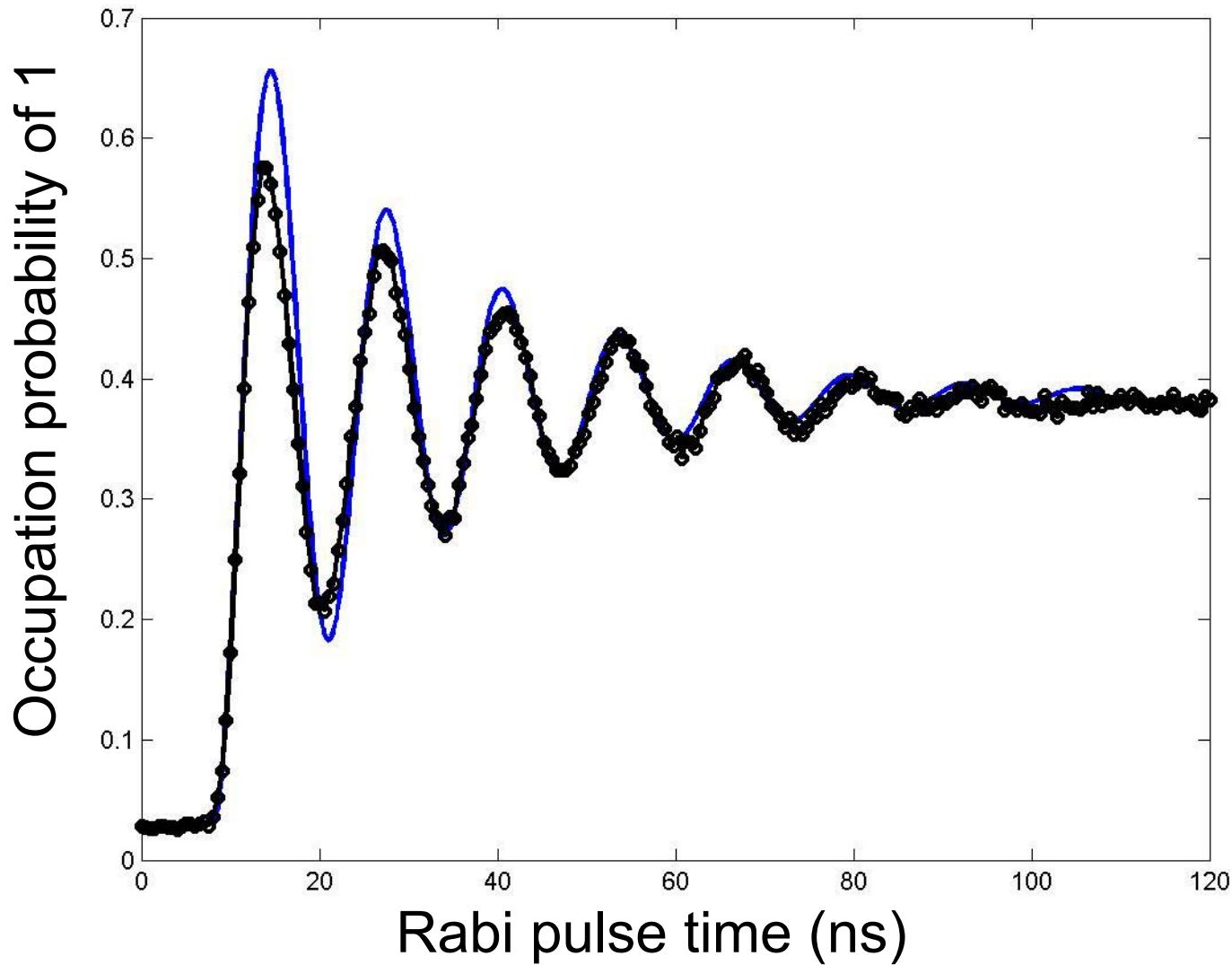


Resonator Magnitudes

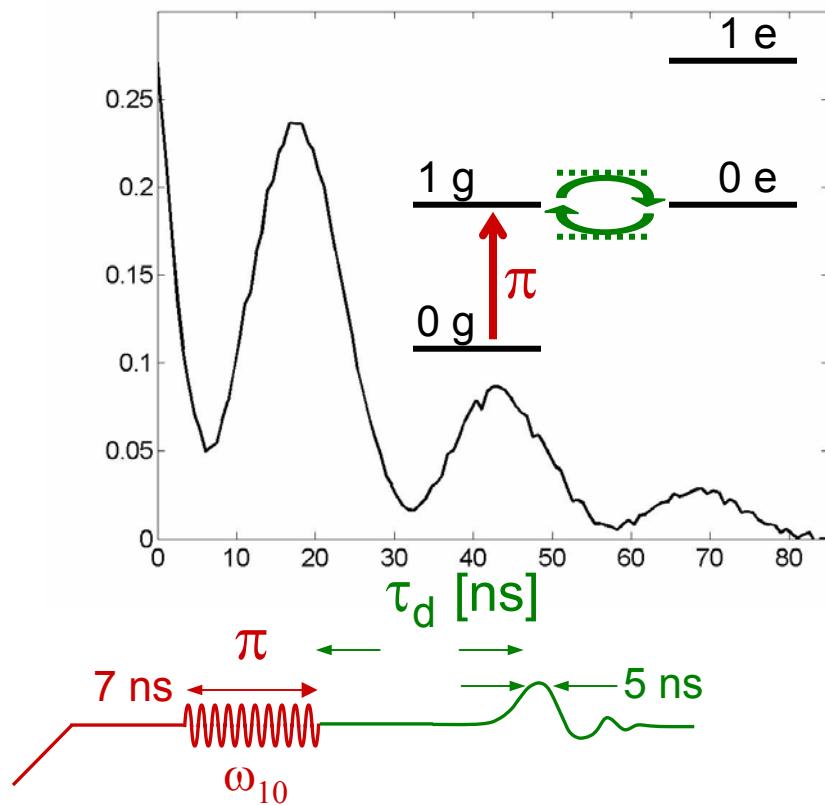
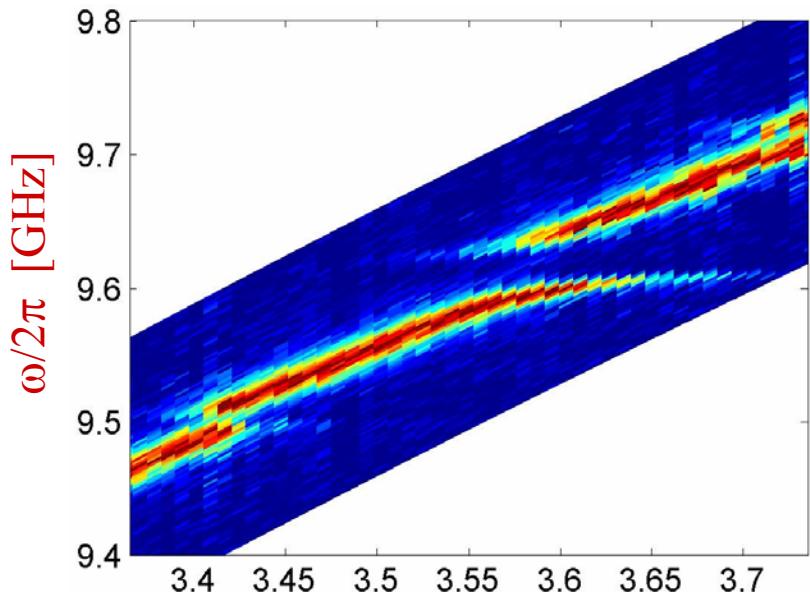


- Fewer resonators with smaller junction – must bias away from large resonances!
(consistent with phase, flux qubits)
- T_1 shorter with small junction – new decoherence source

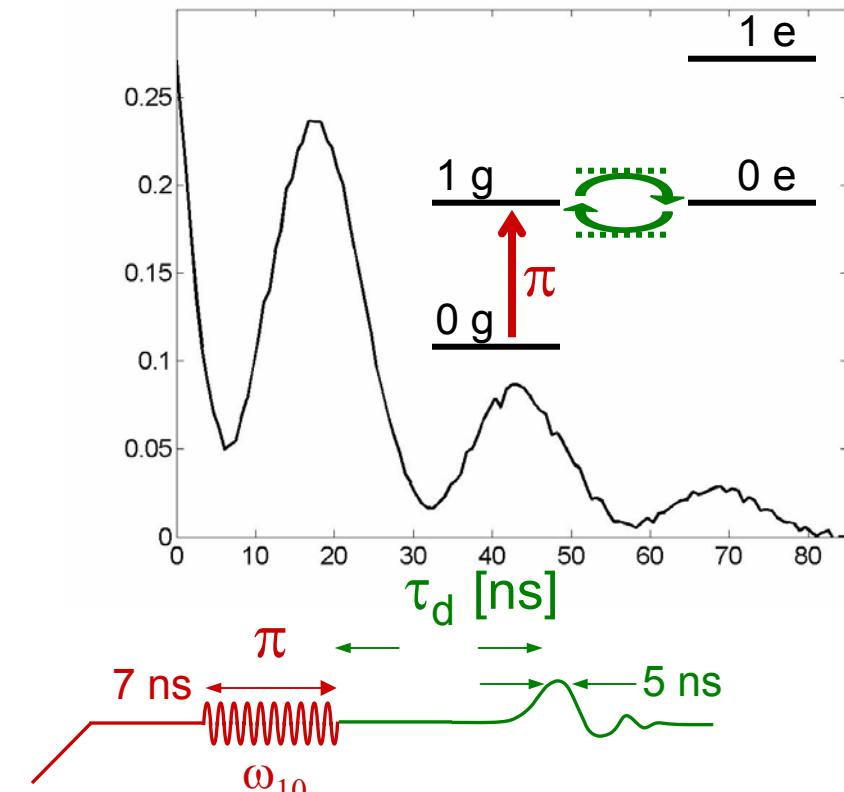
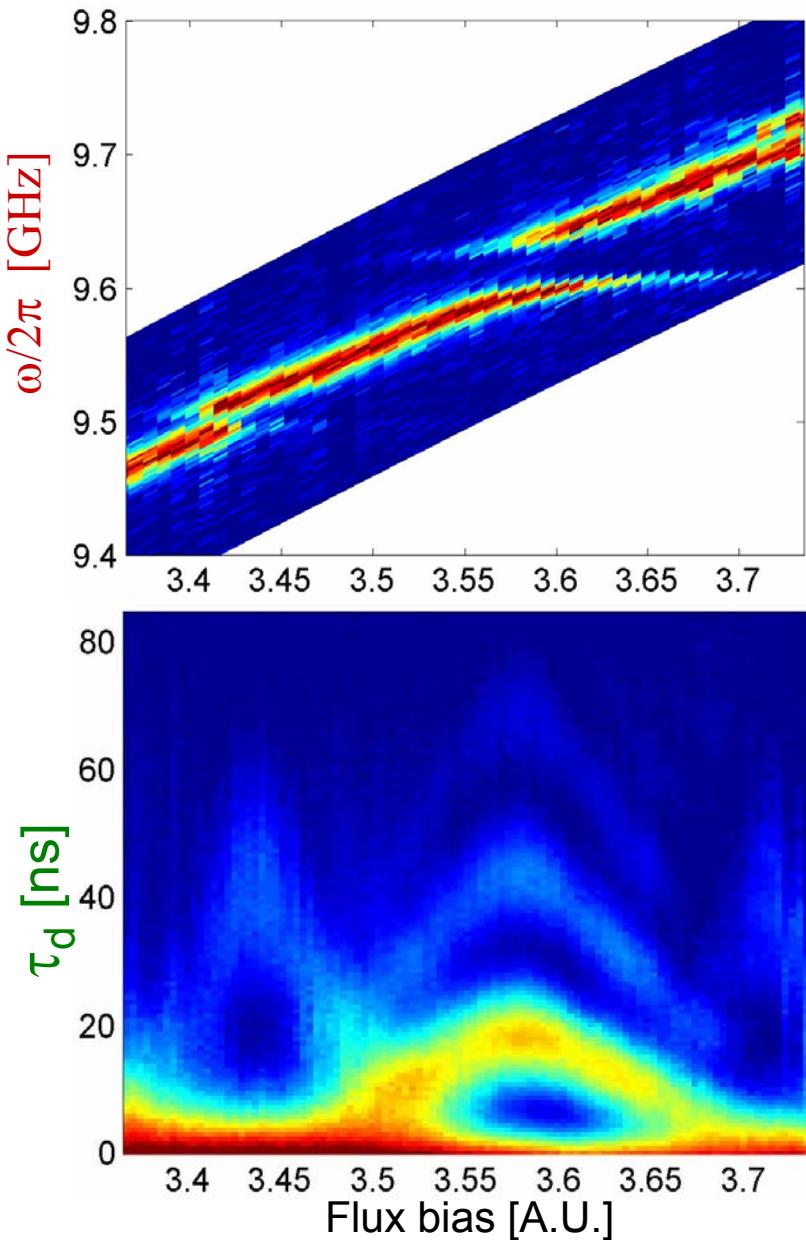
Data from yesterday (small area)



Time-Domain Measurements of Resonance

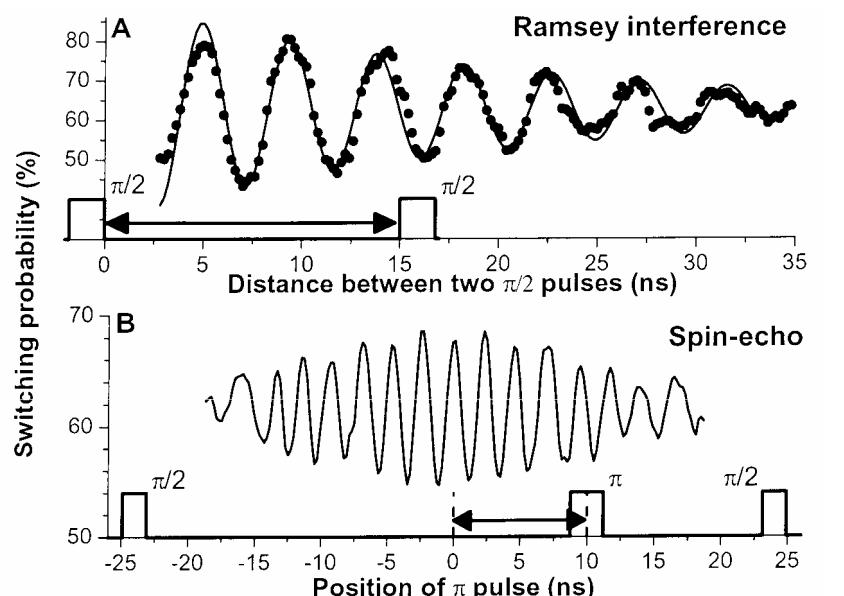
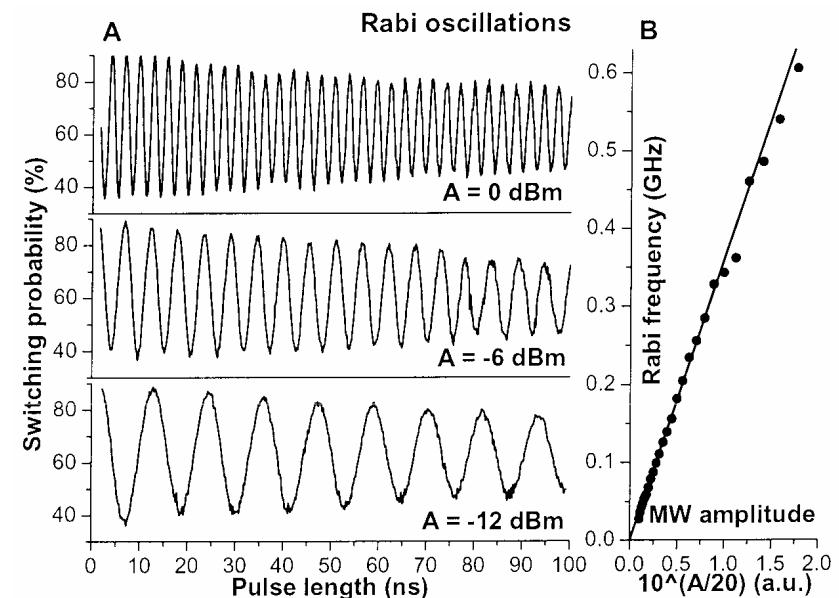
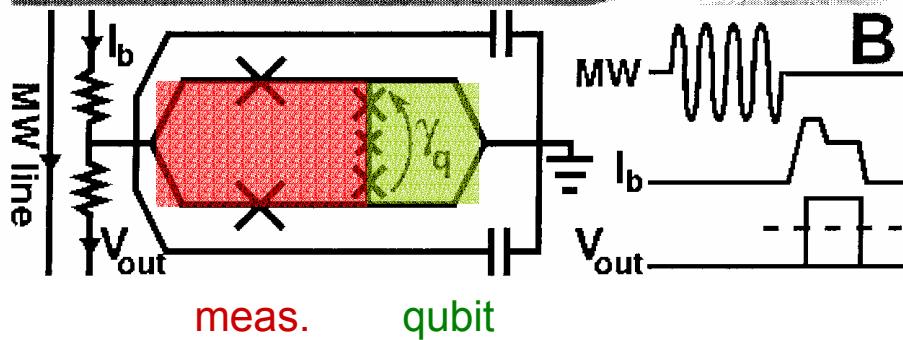
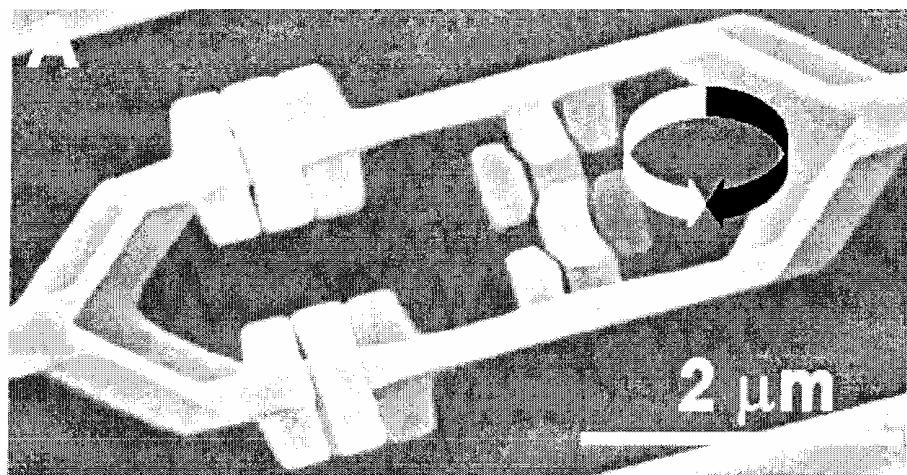


Time-Domain Measurements of Resonance



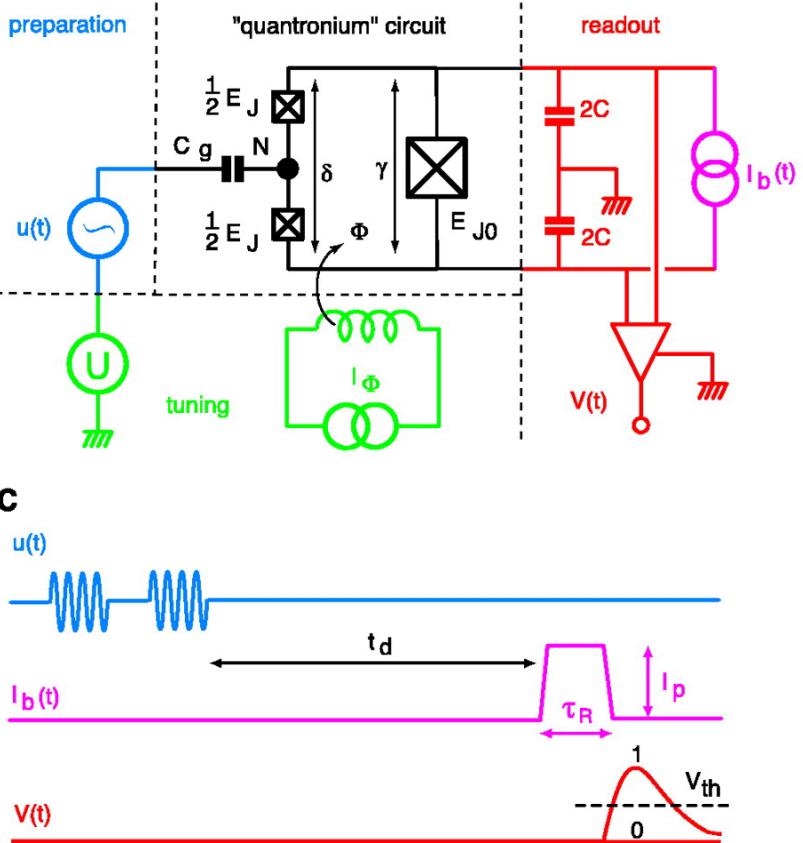
- Resonances are long-lived: cancel with spin-echo techniques?
- “Mock-up” of coupled qubit experiment measure correlation of two states

Flux Qubit (Delft)

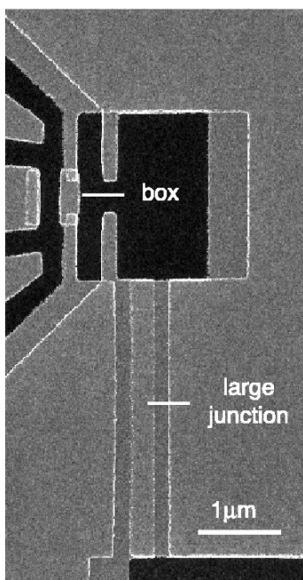


Charge Qubit (Saclay)

A

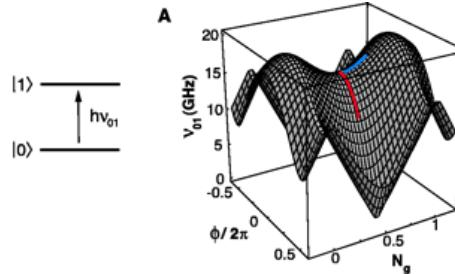


B

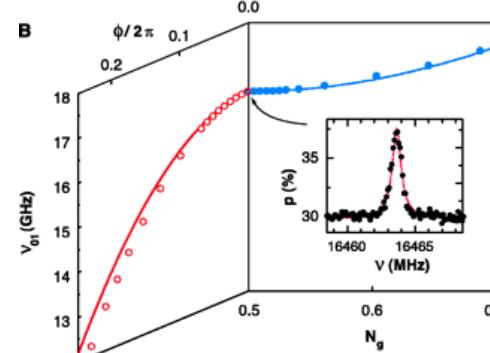


Large 1/f charge noise requires operation at degeneracy point
($d\omega/dq = 0$)

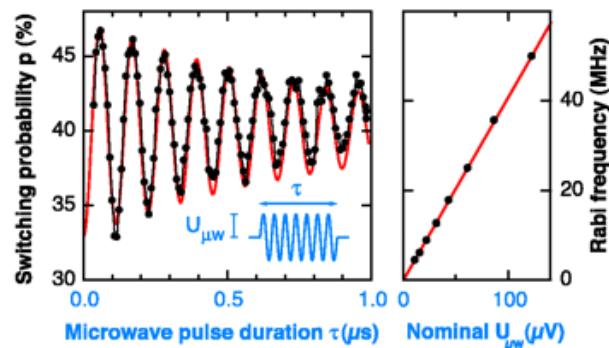
A



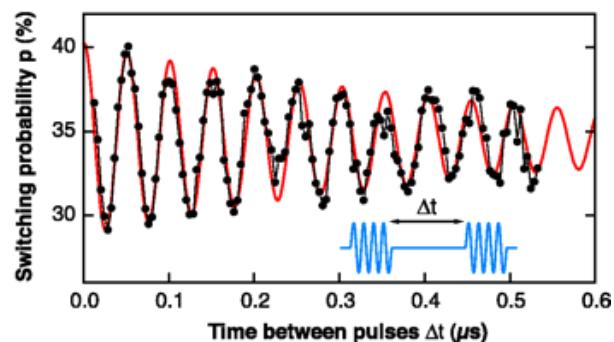
B



A



B



Summary & Future Work

- Understand how to design qubits
- Circuits work:
 - State preparation
 - Logic operation (Rabi oscillations)
 - State measurement
- “Mock-up” of coupled qubit experiment
- Need to eliminate spurious resonances:
 - Microscopic model
 - Understand size dependence
 - New materials - improve upon amorphous AlOx
- “Brute force” scaling to 20-100 (1000) qubits
 - Room temperature sequencer and pulse generators
 - DR with 100-1000 wires

Decoherence from Fluctuations (& resonances)

(with M. Devoret)

$$\begin{aligned} E_J &= E_J^{\text{stat}} + \Delta E_J(t) \\ E_C &= E_C^{\text{stat}} + \Delta E_C(t) \\ Q &= Q^{\text{stat}} + \Delta Q(t) \\ L &= L^{\text{stat}} + \Delta L(t) \end{aligned}$$

med.

?

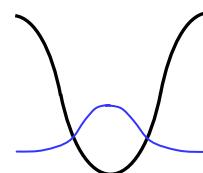
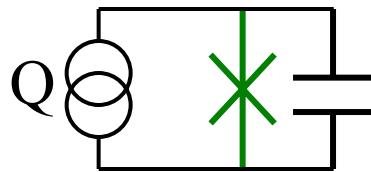
large

?

Parameter
Fluctuations

Occurs in all
qubit systems!

Charge



$$H \approx -\frac{E_J}{2}\sigma_z + \frac{E_C(1-Q)}{2}\sigma_x$$

Large



Low freq.

$$I_0$$

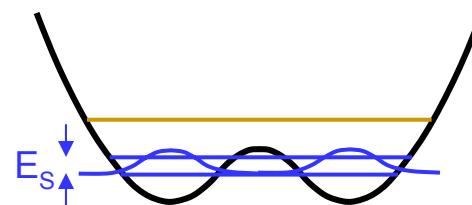
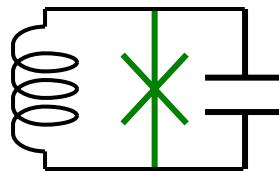
≈ 0



High freq.

$$Q$$

Flux



$$H \approx -\frac{E_s}{2}\sigma_z + \frac{E_\Phi(\frac{\Phi}{\Phi_0} - \frac{1}{2})}{2}\sigma_x$$



Low freq.

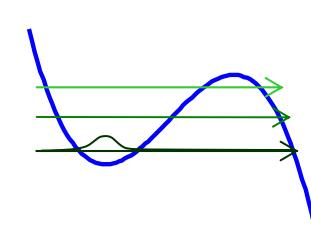
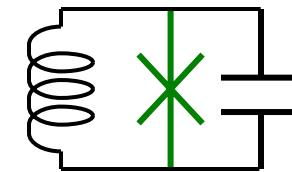
$$I_0, L, C$$



High freq.

$$\Phi, L, (I_0)$$

Phase



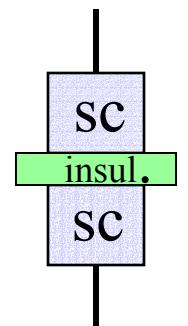
$$H \approx \hbar\omega_{10}\sigma_z + \kappa\Delta I(\sigma_x + \frac{1}{4}\sigma_z)$$



High and low freq.

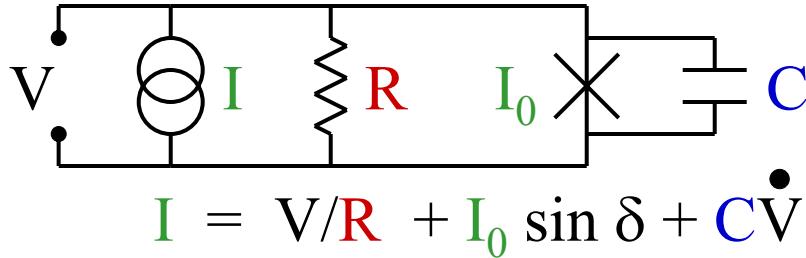
$$\Phi, L, I_0, C$$

Josephson-Junction Physics



$$I_j = I_0 \sin \delta$$

$$V = (\Phi_0/2\pi) \dot{\delta}$$



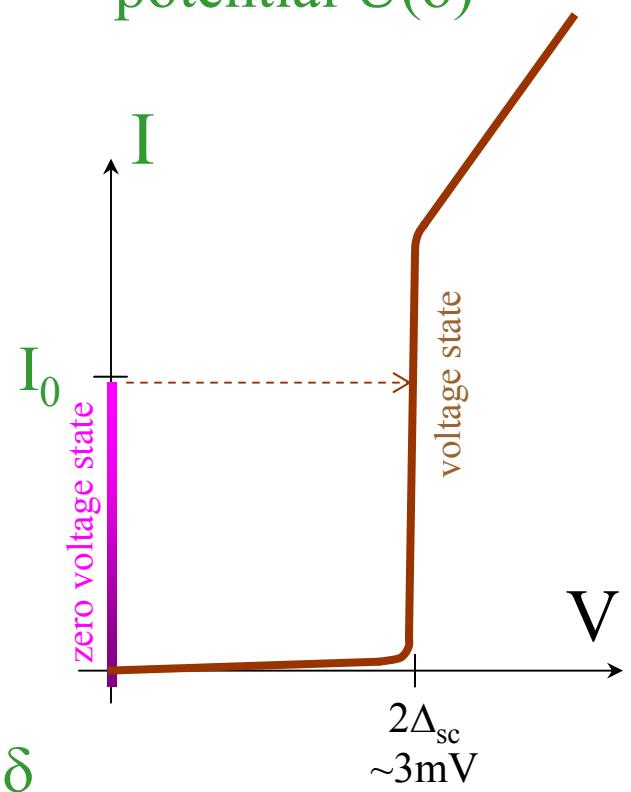
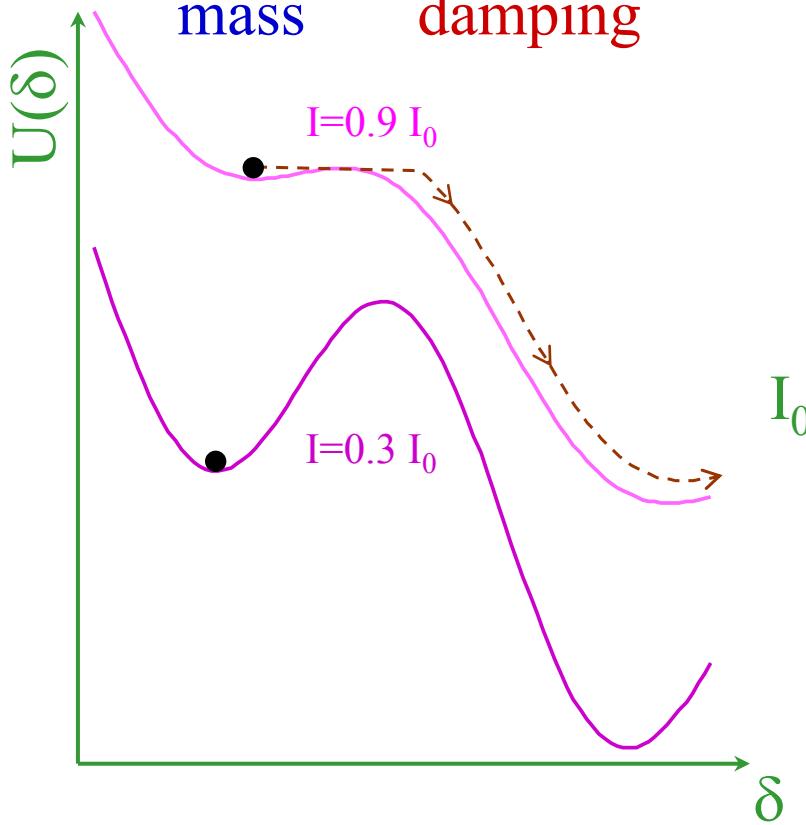
$$I = V/R + I_0 \sin \delta + CV$$

$$\begin{aligned} U &= \int I_J V dt \\ &= \frac{I_0 \Phi_0}{2\pi} \int \sin \delta \frac{d\delta}{dt} dt \\ &= -\frac{I_0 \Phi_0}{2\pi} \cos \delta \end{aligned}$$

$$\left[C \left(\frac{\Phi_0}{2\pi} \right)^2 \right] \ddot{\delta} + \left[\frac{1}{R} \left(\frac{\Phi_0}{2\pi} \right)^2 \right] \dot{\delta} + \frac{\partial}{\partial \delta} \left[-I_0 \frac{\Phi_0}{2\pi} \cos \delta - I \frac{\Phi_0}{2\pi} \delta \right] = 0$$

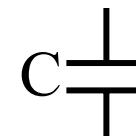
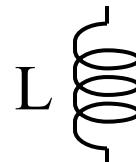
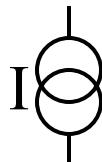
mass damping

potential $U(\delta)$



Qubit Taxonomy

Circuit elements:



Hamiltonian:

$$-\frac{I_0\Phi_0}{2\pi} \cos \delta$$

$$-\frac{I\Phi_0}{2\pi} \delta$$

$$\frac{(\Phi_0\delta)^2}{2L}$$

$$\frac{e^2}{2C} q^2$$

Quantum mechanics:

$$[\hat{\Phi}, \hat{Q}] = i\hbar$$

$$[\hat{\delta}, \hat{q}] = 2i$$

Phase

Non-linearity

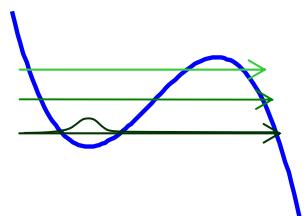
$$I \rightarrow I_0$$

$$\frac{E_J}{E_C} = \frac{I_0\Phi_0 / 2\pi}{e^2 / 2C}$$

Area (μm^2):

10-100

Potential & wavefunction



$$Z_J = 1/\omega_{10} C$$

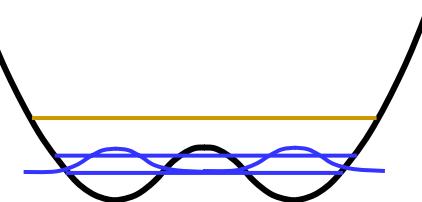
$$10 \Omega$$

Flux

$$L \cong L_{J0}$$

$$10^2$$

$$0.1-1$$



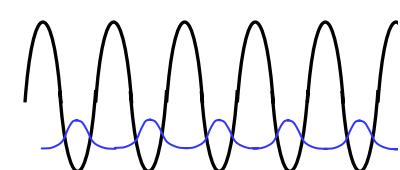
$$10^3 \Omega$$

Charge

Bloch states in δ

$$1$$

$$0.01$$



$$10^5 \Omega$$

Effective Hamiltonian $\sigma \cdot \mathbf{B}$

$$H = \frac{1}{2C} \hat{q}^2 + \frac{\Phi_0}{2\pi} \left[-I_0 \cos \hat{\delta} - (I_{dc} + \Delta I) \hat{\delta} \right]$$

$$= \frac{1}{2C} \hat{q}^2 + H_{cubic}(I_{dc}, \hat{\delta}) - \frac{\Phi_0}{2\pi} \Delta I \hat{\delta}$$

Solve numerically

Perturbation

$$\approx \begin{pmatrix} 0 & 0 \\ 0 & \hbar\omega_{10} \end{pmatrix} + \frac{\Phi_0}{2\pi} \Delta I \begin{pmatrix} \langle 0 | \hat{\delta} | 0 \rangle & \langle 0 | \hat{\delta} | 1 \rangle \\ \langle 1 | \hat{\delta} | 0 \rangle & \langle 1 | \hat{\delta} | 1 \rangle \end{pmatrix}$$

$$= \hbar\omega_{10} \sigma_z + \sqrt{\frac{\hbar}{2\omega_{10}C}} \Delta I \left(\sigma_x + \sqrt{\frac{\hbar\omega_{10}}{3\Delta U}} \sigma_z \right)$$

Basis transform
(rotating frame):

$$V = \begin{pmatrix} 1 & 0 \\ 0 & e^{i\omega_{10}t} \end{pmatrix} \quad \tilde{H} = V^+ H V - i\hbar V^+ (\partial_t V)$$

$$\tilde{H} = \begin{pmatrix} 0 & 0 \\ 0 & 0 \end{pmatrix} + \frac{\Phi_0}{2\pi} (\Delta I_{dc} + I_{uwc} \cos \omega_{10}t + I_{uws} \sin \omega_{10}t) \begin{pmatrix} \langle 0 | \hat{\delta} | 0 \rangle & \langle 0 | \hat{\delta} | 1 \rangle e^{-i\omega_{10}t} \\ \langle 1 | \hat{\delta} | 0 \rangle e^{i\omega_{10}t} & \langle 1 | \hat{\delta} | 1 \rangle \end{pmatrix}$$

$$\approx \frac{\Phi_0}{2\pi} \left(\Delta I_{dc} \begin{pmatrix} \langle 0 | \hat{\delta} | 0 \rangle & 0 \\ 0 & \langle 1 | \hat{\delta} | 1 \rangle \end{pmatrix} + \frac{I_{uwc}}{2} \begin{pmatrix} 0 & \langle 0 | \hat{\delta} | 1 \rangle \\ \langle 1 | \hat{\delta} | 0 \rangle & 0 \end{pmatrix} + \frac{I_{uws}}{2} \begin{pmatrix} 0 & i \langle 0 | \hat{\delta} | 1 \rangle \\ -i \langle 1 | \hat{\delta} | 0 \rangle & 0 \end{pmatrix} \right)$$

$\sigma_z \quad \sigma_x \quad \sigma_y$

Rotating wave approximation (neglect off resonant terms):

Decoherence & Materials

- All oxide tunnel barriers give similar 1/f noise

(Van Harlingen et al)	$S_{I_0}^{1/2}(1\text{Hz})A^{1/2}/I_0$ ($\mu\text{m pA}/\text{Hz}^{1/2}/\mu\text{A}$)
Al-AlOx-Al	(~5)
Nb-AlOx-Nb	7-20
Nb-Ox-PbIn	7-20
Nb-NbOx-PbInAu	8
PbIn-Ox-Pb	15
NbN-AlN-NbN (epi)	1000

- Need Materials Research – Qubits have vastly different requirements

Past Research: High T_c , $Q < 1$, low leakage junctions

Qubits: $T_c > 1\text{K}$, leakage tolerated
low fluctuations, low dielectric loss

- Our research directions:

Barrier uniformity, barrier materials (AlN), epitaxial growth

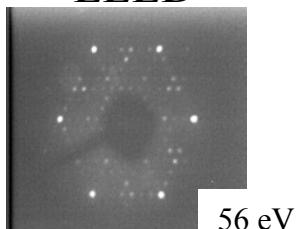
Large-area qubits are ideal test circuits

MBE Growth of Al on Si(111)

- Si(111)-(7×7)
Flash anneal 1250°C
Ordered

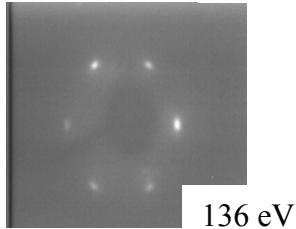
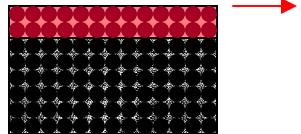


LEED



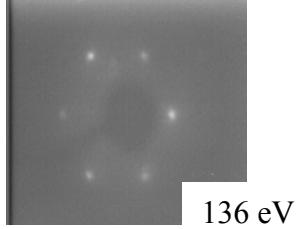
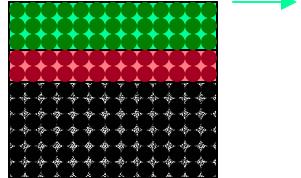
56 eV

- Al seed layer 50 Å
Evap. 100 K
Anneal 450 K
Ordered



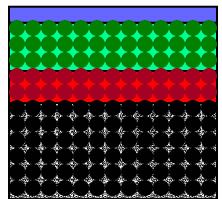
136 eV

- Al homo-epitaxy
Evap. 300K
Anneal 450 K
Ordered

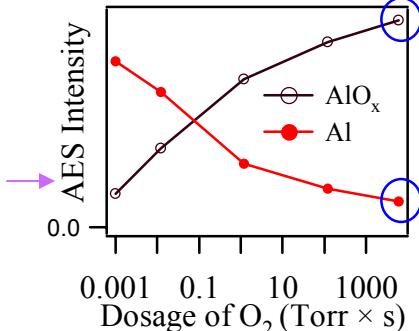


136 eV

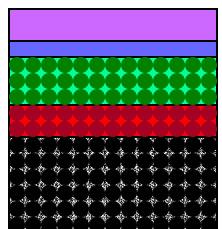
- Oxidation
10T, 10 min, 300K
Amorphous



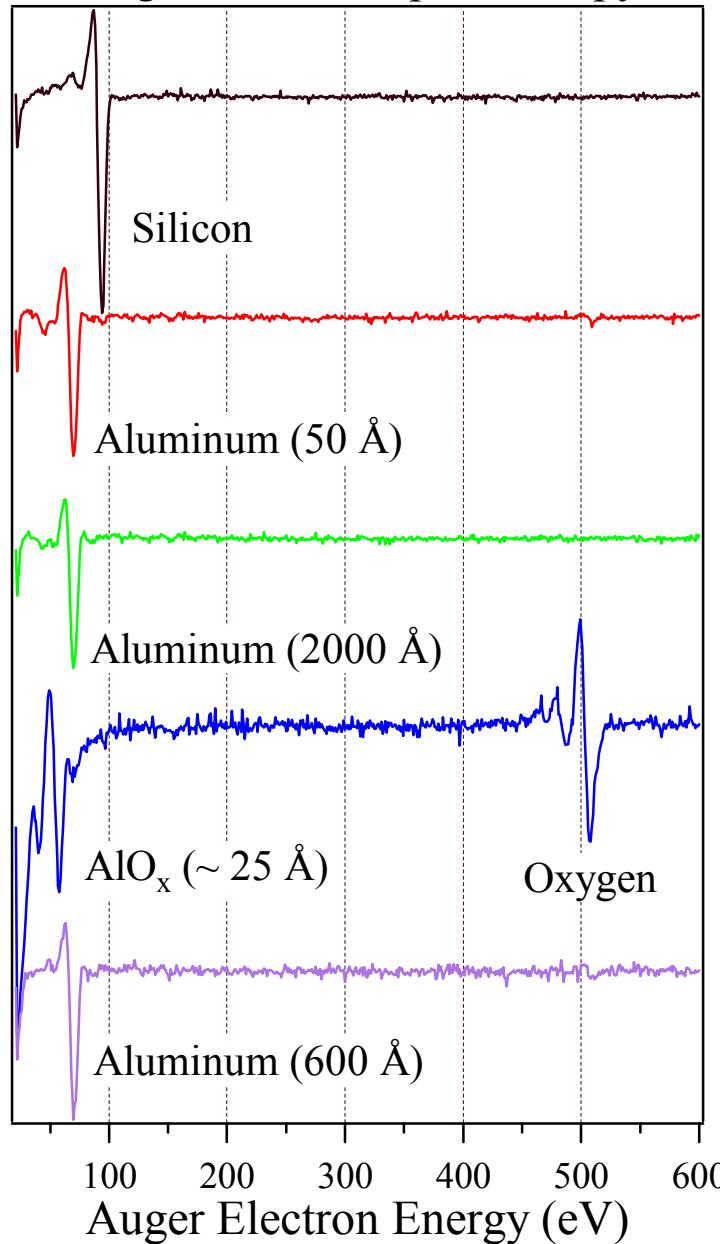
No LEED Pattern



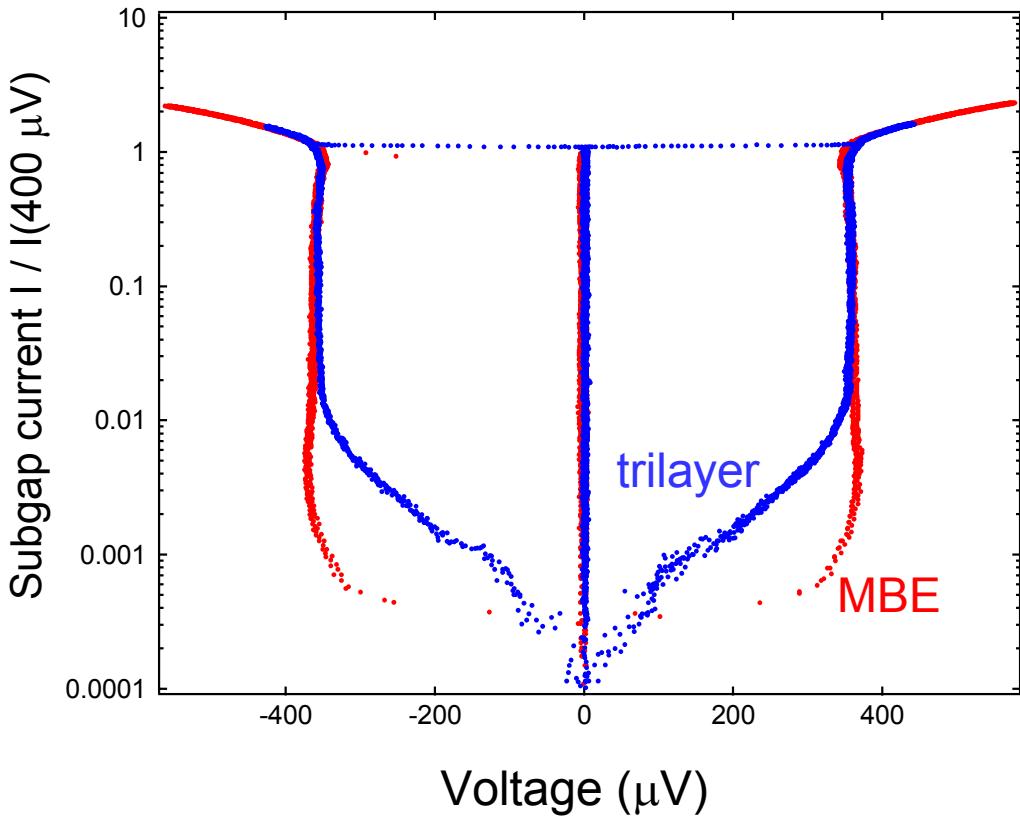
- Al counter-electrode
Amorphous



Auger Electron Spectroscopy



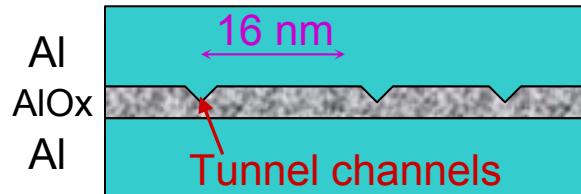
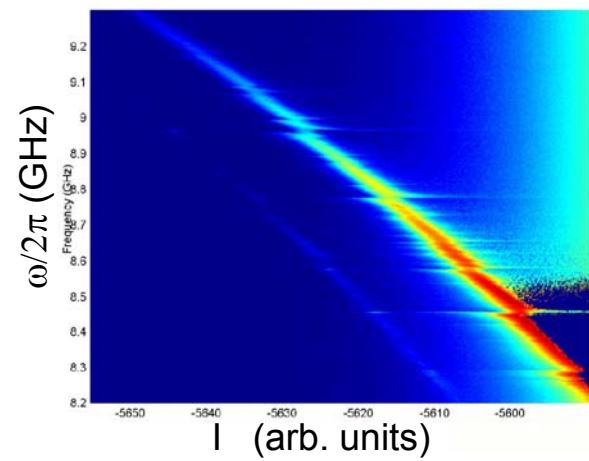
MBE Junctions – Better Quality



Why is junction yield low (30%)?

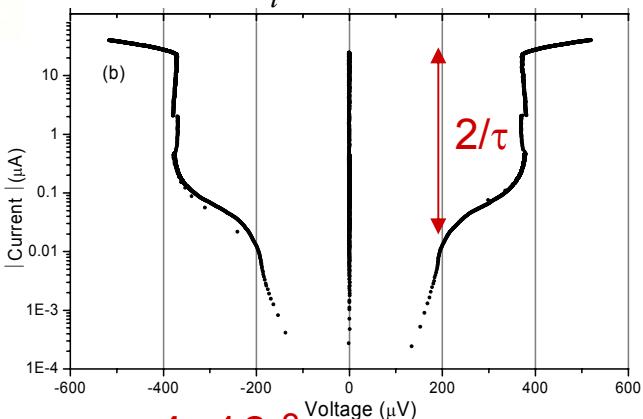
Sputtered films (10^{-10} T chamber) are more reproducible
No change in coherence (low yield, still inconclusive)

Decoherence : IV's : 1/f Noise



$$G_N = \frac{2e^2}{h} \sum_i \tau_i = \frac{2e^2}{h} N_{ch} \tau$$

$$G_{S2} \approx \frac{2e^2}{h} \sum_i \tau_i^2 \quad (\Delta < eV < 2\Delta)$$



- $\tau \sim 4 \times 10^{-3}$
- 1 channel / $(16\text{nm})^2$
- $\Delta I_0/I_0 \sim 8 \text{ ppm}$

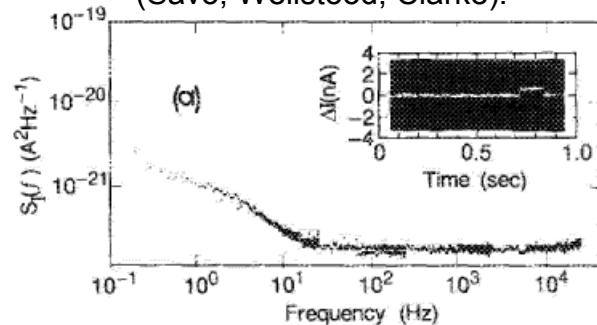


- $\Delta I_0/I_0 \sim 65 \text{ ppm}$
- 5 res. / dec.-fr. - μm^2

Assuming resonances & traps turn on/off channels:

- See individual traps in sub-micron junctions

(Savo, Wellstood, Clarke):



0.1 μm^2 junction (Van Harlingen)

- $\Delta I_0 \sim 10^{-4} I_0$
 $(1/N_{ch} \sim 3 \times 10^{-3})$
- 1 trap / decade freq.

scaling to 32 μm^2

- $\Delta I_0/I_0 \sim 0.3 \text{ ppm}$
- 10 traps / dec.-fr. - μm^2

Resonances and 1/f noise are same phenomenon !